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THESIS

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A Transduction Path Method of Solid State Sensor Analysis and Investigation

by

Curtis L. Dubay

September 1984

Thesis Advisor:

Rudolph Panholzer

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A Transduction Path Method of Solid State Sensor Analysis and Investigation

bу

Curtis L. Dubay Lieutenant, United States Coast Guard B.S., United States Coast Guard Academy, 1979

Submitted in partial fulfillment of the requirements for the degree of

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from the

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ABSTRACT

This paper proposes a "transduction path" method of analysis for solid state sensors. It is based upon the idea that a sensor represents a transduction path from some input measurand to an electrical output. The transduction path may consist of one or more transduction or modification principles drawn from all fields of science. Also proposed is a "transduction path diagram" which provides a graphical representation of a transduction path. Background material concerning the development and description of solid state sensors is presented. Sensor measurands are identified and categorized by energy form. The known transduction and modification principles are presented as fundamental building blocks of the transduction path and cross-indexed by measurand. The transduction path diagram is introduced and examples of existing single and multistep transducers are presented. Finally, the transduction path method is shown to be valuable as a systematic method of investigating sensor configurations. The Appendix to the control of the control

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I. INTRODUCTION

A. DEFINITIONS

In order to gain an understanding of solid state sensor operation and their capabilities, it is necessary to present a few definitions. For the purpose of this paper, state sensor may be regarded as a device that converts a physical quantity, or measurand, into an electrical signal of significant fidelity that is compatible with integrated circuit technology and relies upon the principles of solid state physics for its operation. The measurand represents information about an aspect of the physical world which, for one reason or another, is the object of measurement. information is carried by a signal which is characterized as belonging to one of seven different forms of energy. forms include mechanical, thermal, electrical, magnetic, optical, chemical, and nuclear energy.

The process by which one form of energy is converted into another form of energy is known as transduction. instance, a light emitting diode is a transducer which converts electrical energy to optical energy. Likewise, photocell performs the inverse operation, and transduces optical energy to electrical energy. The process by which one form of energy is changed to a like form of energy is known as modification or signal processing. An example of a mechanical to mechanical modifier would be the gear system in the transmission of an automobile. The energy form is not changed, but the mechanical angular velocity of the output is different from that of the input. Another example of a modifier is the operational amplifier, which may be regarded as an electrical to electrical modifier, or signal

processor. An electrical signal is applied to the input and a processed electrical signal is extracted at the output.

In a solid state sensor, the conversion of a measurand into an electrical signal takes place along a transduction path, which consists of one or more discrete transduction or modification steps. This transduction path approach is central to the subject of this paper and will be addressed in detail in later chapters. The basic concepts of sensors are closely related to the topic of instrumentation which is discussed fully in [Ref. 1].

B. TRADITIONAL SENSORS

The development of science throughout history has been closely tied to man's ability to sense, or measure, the world around him. Man possesses five natural senses which enable him to detect physical phenomena, but only within set limits of perception and only in his presence. In time, a need developed for devices that would sense physical phenomena outside of man's natural limits or not in his presence. These devices are referred to as sensors or transducers, and represent a means by which man can expand his natural senses to perceive more of the physical world than would otherwise be possible.

The generation of sensors and transducers that precedes solid state sensors may be referred to as the traditional generation of sensors. This generation is 'aracterized by a physical scale that is compatible with design and fabrication by the human hand and eye. While some automation is typically used in the fabrication of such devices, the physical scale is usually compatible with some degree of hand assembly. Illustrative examples of the traditional generation of sensors include the mercury thermometer, aneroid barometer and pendulum clock. These

devices convert, or transduce, temperature, pressure, or time into a mechanical signal that man is capable of sensing and interpreting. This mechanical signal contains the information about the aspect of the physical world under measurement.

The traditional sensors possess several disadvantages that make the next generation of sensors, solid state, very attractive. Chief among these disadvantages are size and The part count of a traditional sensor tends to be comparatively high. This, coupled with a feature size compatible with the human hand and eye, results in a sensor of considerable bulk and weight. This is particularly true when a comparison is made with integrated circuit devices fabricated by photolithography with a feature size on the few microns. part count order of a The high considerable reliance on hand assembly combine to make the traditional generation of sensors expensive. In the next we shall see how solid state sensors necessary to alleviate some of these problems and make inexpensive sensing possible.

C. SOLID STATE SENSORS

Recent advances in the fabrication οf integrated circuits have brought about a revolution in the field of information processing. Single chip microcomputers of considerable capability have appeared that are making the concept of component computers a reality. With the increased flexibility that this provides in the development of new and complex systems, electronics is infiltrating into more fields than ever before. But the increased capacity for information processing in turn gives rise to a need for increased input of data or information pertaining to physical world. In the past, much of this information from the physical world has been detected by humans or machines and subsequently encoded into the processor as data. To make efficient use of the speed with which modern microcomputers operate, the data collection process likewise has to be fast and efficient.

Solid state sensors represent a means by which data on physical phenomena may be rapidly collected and assimilated. They convert a measurand into an electrical signal that can be subsequently changed into digital data through the process of analog to digital conversion. This data collection process can fall into two main categories. The first is that of the real time transducer which continuously monitors the measurand and provides continuous data for processing. The second is that of the non-real time transducer which is used primarily to determine the status of a particular measurand and may be activated only when a preset threshold is exceeded [Ref. 2].

the cost of computing power was In the past, prohibitive that it precluded the use of microcomputers in many applications. However, batch fabrication techniques and advances in integrated circuit design have brought the cost of microprocessors and microcomputers down to a level where they have become economical as component computers. In many applications of microcomputers, it is found that much of the cost resides in the peripheral devices rather than the processor itself. In the particular case of sensor input to a microcomputer, a need arose for inexpensive devices that would carry out the functions The problem reduced to one of collection and dissemination. efficiently merging the fields οf sensors microprocessors. As it turned out, the silicon integrated circuit industry provided many of the techniques necessary to fabricate such devices.

The most common materials for the fabrication of solid state sensors are silicon, doped silicon, quartz, and optical fibers. Solid state sensors constructed of silicon enjoy many of the advantages of batch fabrication techniques developed by the silicon integrated circuit industry. Much of the wealth of experience gained in processing silicon for integrated circuits has been useful in developing solid state sensors. In this respect, it can be said that silicon solid state sensor technology has developed on the coattails of integrated circuit technology.

Like integrated circuits, the physical scale of solid state sensors is limited only by the resolution of the photolithography techniques employed. This represents a major improvement over the previous generation of sensors which is characterized by a physical scale compatible with hand assembly on a per-unit basis.

The silicon used in the fabrication of sensors is single crystal which makes the sensor a monolithic device with practically no measurable hysteresis. Using silicon as a substrate material also opens the possibility of a sensor with onboard signal processing using integrated circuit technology. Carried to the extreme, this could mean the development of a smart sensor with its own dedicated microcomputer on board. 0ne advantage of such arrangement would be that inherently nonlinear transduction principles could be utilized without substantial penalty Such an arrangement could also take advantage of the fact that silicon integrated circuits have a mean time to failure of 1011 hours per gate which is 103 times better than that of discrete transistor circuits and 105 better than that of vacuum tube circuits [Ref. 4]. coupled with the exceptional physical properties of single crystal silicon, makes possible a generation of sensors with onboard signal processing of much greater reliability than ever before.

Other performance characteristics of sensors that should be considered include accuracy, linearity of response, size, weight and dynamic range. Accuracy of solid state sensors is often superior to the traditional sensors owing to the lack of hysteresis in monolithic silicon. As noted before, a nonlinear characteristic can be negated as a drawback when proper signal processing is applied. Often, this also gives rise to an increased dynamic range when the sensor is no longer restricted to the linear portion characteristic curve. Solid state sensors enjoy a firm advantage over traditional sensors in the areas of size and weight since solid state sensors benefit from many of the advantages of modern photolithography techniques.

The other mediums commonly used for solid state sensors share many of the same advantages as silicon solid state sensors. However, the use of optical fiber as a sensing medium offers the option of a distributed sensing element of tremendous sensitivity. As the wavelength of light is so very short in comparison to many of the phenomena being measured, very high resolution is possible.

D. APPLICATIONS

As sensors truly represent a link between the worlds of applied physics and electronics, it is likely that the future will see the role of solid state sensors continuing to expand. One area in which solid state sensors have very important is the field of automotive electronics. Nearly all domestic cars being produced now contain at least one sensor under microprocessor control One of the reasons the field of automotive electronics has grown so rapidly is that current technology has made such techniques economically feasible. automotive engineer now has a whole new set of tools with which he can work to improve engine efficiency and ensure compliance with emission standards. By monitoring such critical engine parameters as crankshaft angle position, manifold absolute pressure, manifold vacuum, ambient absolute pressure, air flow, oxygen partial pressure, flow, coolant temperature, air temperature, and throttle position, the automotive engineer can control engine performance as never before possible [Ref. 5]. Excellent summaries of automotive engine control sensor technology are available in References 5-8. Also, it is interesting to note that Detroit uses more absolute pressure sensors in one year than had been produced everywhere for all purposes up to the year 1980 [Ref. 3].

Another area seeing important progress in implementation of solid state sensors is that of robotics. Many of the robotic arms that have been developed rely upon mechanical rigidity for repeatability of movement. Construction techniques allowing precision movements within strict tolerances have been heavily relied upon. By employing sensor feedback with real-time microprocessor control systems, it should be possible to utilize a comparatively sloppy and loose manipulator for exacting applications. Additionally, robotic navigation and collision avoidance become possible when sensor feedback is introduced into the Much work is currently being carried out in this area. Useful background information on sensor based robotics is contained in [Ref. 9].

Other applications for solid state sensors include cameras, appliances, biomedical instruments, spacecrafts, weapons, antipollution devices, weather monitoring equipment, and microprocessor-based control systems in industry.

II. OBJECTIVES

A. PROBLEM STATEMENT

The field of solid state sensors encompasses tremendously diverse body of knowledge. Principles from all of the known fields of science are employed in solid state sensor design. On one side of a solid state state sensor is the physical world. This physical world is the province of many specialists, including chemists, physicists, mechanical engineers, to name only a few. On the other side of a solid state sensor is the world of electronics. is the express province of the electrical engineer. Serving as a bridge between the world of pure physical science and the world of electronics is a hybrid field, that of the sensor and transducer engineer.

Due to the extremely diverse nature of the field, a problem exists for the electrical engineer interested in solid state sensors. A method has been lacking by which the entire range of sensors, both actual and theoretical, may be systematically described. Such a method would make it possible to examine the entire field in such a manner that it would be possible to determine where implementation has fallen short of theoretical possibility. The method needs to be able to describe existing sensors as well as aid in the investigation of sensor configurations.

B. CURRENT METHODS

The first step towards such a work is an evaluation of the current state of the technology. In order to perform such an evaluation, it is necessary to review the manner in which a transducer is currently described. During the 1960's, a great variety of traditional sensors and transducers became available in support of the space program. A need developed for a standardized method of specifying sensors and transducers. Such a standard was developed under the auspices of the Instrument Society of America in 1969 and accepted as American National Standard, ANSI MC6.1-1975 in 1975 [Ref. 10]. The practices set forth by this standard specify that a sufficient description is given when the measurand, the transduction principle, the sensing element, the range, and any special features are specified.

The measurand represents that quantity which is intended to be measured. The transduction principle is the operating principle of the electrical portion of the transducer from which the output originates. The sensing element is that physical part of the transducer which directly responds to the input measurand. Examples of special features may include digital output and temperature compensation. The range is described by the upper and lower limits of the measurand between which the transducer is intended to operate. As an illustrative example, a Hall effect current sensor could be described as "Transducer, current, Hall effect, non-contact, 0-1 Amp". [Ref. 10]

C. PROPOSED SOLUTION

As seen above, the standard only specifies the last step of the transduction process, which converts the measurand to an electrical signal. However, many transducers are multistep devices which utilize more than a single transduction or modification process. To account for this, and allow greater flexibility in describing sensors, a "transduction path" method of analysis is hypothesized. It is based on the idea that a sensor represents a transduction

path from a measurand to an electrical quantity. The consists of one or transduction path more discrete transduction or modification steps. The transduction path may be illustrated in graphical form through a "transduction path diagram". This diagram is capable of not only describing the operation of existing sensors, but also may in the systematic investigation οf sensor configurations.

D. PROCEDURE

This paper proposes a "transduction path" method of analysis for solid state sensors resulting in the development of a "transduction path diagram". This diagram is capable of illustrating the operation of an existing sensor as well as allowing the systematic investigation of sensor configurations. Several phases were required in the development of this method.

the identification The first phase required categorization by energy form of sensor measurands. The results of this process are presented in Chapter III. The second required the phase identification of known transduction and modification principles drawn from fields of science. These are presented as fundamental blocks of the transduction path and cross-indexed by measurand in Chapter IV and Appendices I The third phase required the development of a structure which would systematically interconnect all of the trandsduction and modification principles identified. "transduction path diagram" described in Chapter V proposed as such a structure. In order to test information was collected on 108 classes of sensors from literature sources and commercial suppliers. The transduction path of each sensor was then determined and

examined for compatibility with the transduction path diagram. Representative results are presented in Chapter V. In the fourth phase, sensor configurations were systematically investigated using the transduction path method. Conclusions and an overview of the method are presented in Chapter VI.

III. MEASURANDS

A. CLASSIFICATION OF MEASURANDS

In order to adequately describe the various transduction and modification steps that may be utilized in transducers, it is necessary to identify the measurands involved. The measurand of a sensor contains information about an aspect of the physical world that is the object of measurement. This information is carried by a signal which is manifested as some form of energy. Seven forms of energy have been identified which are sufficient to describe the signals bearing information about the measurand. These are mechanical, thermal, electrical, magnetic, optical, chemical, and nuclear forms of energy.

The electrical, magnetic, optical and nuclear forms of energy are all related by the laws of electromagnetic theory. Electrical and magnetic phenomena fall at the DC and low frequency end of the electromagnetic spectrum. Optical phenomena fall within a higher frequency range of the electromagnetic spectrum, ranging from infrared through ultraviolet. Nuclear phenomena lie at the high end of the electromagnetic spectrum and represent the most energetic of the electromagnetic waves. Mechanical phenomena generally represent an ordered form of energy on a macroscopic scale, while thermal phenomena represent a disordered form of energy on a submicroscopic scale. Chemical phenomena rely upon the principles of interatomic bonding and sharing of electrons to explain their behavior.

Common to all of these phenomena is the idea that a signal containing information is available in one of the seven forms of energy. For instance, pressure is a physical

quantity that commonly is the subject of measurement. It may be represented as a time-varying signal belonging to the mechanical form of energy. Likewise, light intensity is a physical quantity that may be represented as a time-varying signal belonging to the optical form of energy.

The physical quantities associated with the transduction and modification principles identified in the next chapter are listed in Tables I through VIII. These particular physical quantities, or measurands, have been found to figure prominently in the sensors and transducers available In order to mathematically express these measurands, an international system (SI) of measurement was developed. The six basic units of the SI measurement system are length, mass, time, current, temperature, and luminous intensity. These basic units have been adequately described in the literature and are simply mentioned here. Furthermore. these six basic units are sufficient to describe all of the measurands belonging to the seven forms of energy. Complete listings of physical quantities associated with each form of energy are attached as Appendices A through G. particular physical quantities which serve as measurands for the transduction and modification principles are capitalized in these appendices. The non-capitalized entries provided in the interest of completeness.

1. Mechanical Measurands

Identification of mechanical measurands may be guided by the following definitions. Mechanical energy is the sum of kinetic energy and potential energy. Kinetic energy is referred to as the energy of motion while potential energy is referred to as the energy of position. The process by which the kinetic or potential energy is changed is called work. Kinetic energy, potential energy, and work are all relevant to the physics of macroscopic

mechanics. In general, a measurand may be classified as a mechanical measurand if the physics of macroscopic mechanics apply.

In many cases, it is possible to mathematically express one measurand in terms of a different, but related, measurand. For example, velocity is the first derivative of position and acceleration is the first derivative of velocity.

The physical quantities serving as mechanical measurands for the transduction and modification principles of the next chapter are listed in Tables I and II. For a complete listing, see Appendix A.

2. Thermal Measurands

The thermal measurands deal with a form of energy that is disordered, or random in nature. It is associated with the submicroscopic behavior of atoms and molecules of a system. The manner in which energy is transferred in thermal systems is known as heat, which is a form of work. The most commonly used measurand in the thermal domain is temperature. It is a measure of the random kinetic energy of the atoms and molecules in a system. In many cases, it is possible to mathematically express one measurand in terms of a different, but related, measurand. For example, the field of thermodynamics contains many equations pertaining to the transfer of thermal energy.

The physical quantities serving as thermal measurands for the transduction and modification principles of the next chapter are listed in Table III. For a complete listing, see Appendix B.

3. Electrical Measurands

The electrical measurands—lie at the DC or low end of the electromagnetic spectrum. The concepts of charge and

TABLE I Mechanical Measurands I

ACCELERATION
ACOUSTIC ENERGY
ACOUSTIC WAVE
ANGLE
ATTRACTION, MAGNETIC
CONTRACTION, LATERAL
DEFLECTION
DEFLECTION
DEFORMATION
DENSITY
DIAMETER, CONDUCTOR
DIAMETER, WIRE
DIMENSION
DIPOLE ALIGNMENT
DIRECTION OF MOTION
DISPLACEMENT
ELASTIC PROPERTIES
FLOW
FLOW, FLUID
FLOW, FLUID
FLOW RATE, MASS
FORCE
FREQUENCY, ACOUSTIC
FREQUENCY, MECHANICAL
FREQUENCY, FLEXURAL
FREQUENCY, FLEXURAL
FREQUENCY, TORSIONAL
FRICTION
FRICTION, LIQUID
FRICTION, SOLID
HARDNESS
IMMERSION, PARTICLE
INCLINATION
LENGTH
LEVEL, LIQUID

charge carriers are closely related to most of the measurands associated with electricity. These measurands may describe the charge itself, or they may describe the external factors which determine the behavior of For instance, the physical quantity of resistance affects the manner in which charge propagates through a material giving rise to current. Once again, it is possible to mathematically express many of the electrical measurands in terms of other electrical measurands. A particularly well known example of this is Ohm's Law.

TABLE II Mechanical Measurands II

MICROBENDS
MOMENTUM, ANGULAR
MOVEMENT, AIR
MOVEMENT, POLAR FLUID
PATH LENGTH DIFFERENCE
POSITION
POSITION, ANGULAR
PRESSURE
PRESSURE, SOUND
PRESTRAIN
PROXIMITY
PROXIMITY
PROXIMITY
PROXIMITY
PROXIMITY
PROXIMITY
PROXIMITY
SEPARATED GASES
SHAPE
SHOCK
SOUND
STRAIN, LOCALIZED
STRESS
STRESS, LONGITUDINAL
TENSION
TENSION, SURFACE
THICKNESS
TOROUE
ULTRASONIC
VELOCITY, ANGULAR
VELOCITY, AIR
VELOCITY, SAW
VIBRATION
VOLUME
WAVELENGTH

The physical quantities serving as electrical measurands for the transduction and modification principles of the next chapter are listed in Table IV. For a complete listing, see Appendix C.

4. Magnetic Measurands

The magnetic measurands, like the electrical measurands, lie at the DC or low end of the electromagnetic spectrum. Magnetic phenomena, by definition, result from

TABLE III Thermal Measurands

CONDUCTIVITY, THERMAL HEAT
HEAT FLUX
HEAT TRANSFER RATE
POINT, BOILING
POINT, FREEZING
TEMPERATURE
TEMPERATURE CHANGE
TEMPERATURE, COOLING
TEMPERATURE OIFFERENCE
TEMPERATURE GRADIENT
TEMPERATURE, NOISE

charge in motion. Electromagnetic theory is that body of knowledge which binds the electric and magnetic phenomena together. It is a well known fact that electricity and magnetism are closely related and easily converted from one form to another. For example, an electric generator relies upon both electric and magnetic principles for its operation. The relations are well understood and readily available in equation form.

The physical quantities serving as magnetic measurands for the transduction and modification principles of the next chapter are listed in Table V. For a complete listing, see Appendix D.

5. Optical Measurands

The optical measurands are associated with those electromagnetic phenomena which occur in the range of infrared to ultraviolet. Unlike the low end of the spectrum, few attempts are made to consider the orthogonal electric and magnetic components separately. These measurands attempt to describe the factors that affect the

TABLE IV Electrical Measurands

CAPACITANCE
CHARGE
CHARGE CARRIER
CHARGE LOSS
CONDUCTIVITY
CORONA DISCHARGE
CURRENT
CURRENT, RESTORING
CURRENT, VACUUM
DIELECTRIC FIELD
ELECTRIC FIELD
ELECTRIC FIELD, AC
ELECTRONS
EMF
EMF, AC
EMF, DC
EMF, GATE
FREQUENCY, DIFFERENCE
FREQUENCY, ELECTRIC
FREQUENCY, ELECTRIC
FREQUENCY, ELECTROMAGNETIC
FREQUENCY, RESONANT
IMPEDANCE
INDUCTANCE
IONIZATION
POWER
RADIATION, ELECTROMAGNETIC
RESISTANCE
RESISTANCE
RESISTANCE
RESISTANCE
VOLTAGE
WAVE, ELECTROMAGNETIC

propagation and behavior of optical energy. For instance, reflectivity at an air-fiber interface determines the amount of light which may be coupled into an optical fiber. This is particularly important when designing an optical communications link and calculating the optical power budget. The field of optics has many such relations readily available in equation form.

The physical quantities serving as optical measurands for the transduction and modification principles

TABLE V
Magnetic Measurands

FLUX, CHANGE
FLUX DENSITY
FREQUENCY, ELECTROMAGNETIC
MAGNETIC FIELD
MAGNETIC FIELD, DYNAMIC
MAGNETIC FIELD, STATIC
MAGNETIC FIELD, STATIC
MAGNETIC INDUCTION
MAGNETIC INDUCTION
MAGNETIZATION DIRECTION
MAGNETIZATION, SUDDEN
PARAMAGNETISM
PERMEABILITY
RADIATION, ELECTROMAGNETIC
WAVE, ELECTROMAGNETIC

of the next chapter are listed in Table VI. For a complete listing, see Appendix E.

6. Chemical Measurands

The chemical measurands are associated with the manner in which atoms and molecules share electrons, or bond together. A field of science that is well understood has built up around this molecular bonding. The applications in solid state sensor technology have not been developed very far, however, due to the lack of suitable device configurations. Once again, it is possible mathematically express one measurand in terms of a different, but related, measurand. Chemistry has many such relations available in equation form. In this particular however, the formula is often expressed in chemical symbols rather than conventional mathematical symbols.

The physical quantities serving as chemical measurands for the transduction and modification principles of the next chapter are listed in Table VII. For a complete listing, see Appendix F.

TABLE VI Optical Measurands

ABSORPTANCE
COLOR, ANY
COLOR, PRIMARY
COUPLING COEFFICIENT
FREQUENCY, OPTICAL
ILLUMINATION, DIFFERENCE
IMAGE, DECEPTIVE
IMAGE, OPTICAL
INFRARED RADIATION
LIGHT
LIGHT EMISSION
MAX ENERGY WAVELENGTH
MAX POLARIZED LIGHT
OPAQUENESS
OPTICAL COUPLING
OPTICAL POWER
PHASE DIFFERENCE
POLARIZATION
POLARIZING ANGLE
RADIANT HEAT
REFLECTION COEFFICIENT
REFLECTIVITY
REFRACTIVE INDEX
SPECTRAL LINE SEPARATION
TRANSMISSIVITY
ULTRAVIOLET LIGHT
VISIBLE LIGHT

7. Nuclear Measurands

The nuclear measurands deal with phenomena that lie the high end of the electromagnetic spectrum. Of particular interest in this area is the ability to detect the presence of ionizing radiation. This has many applications in the fields of nuclear physics, spacecraft design, medicine, and nuclear power. Many nuclear equations are available to describe particular events and effects. Perhaps the most famous of these equations is the one developed by Einstein relating mass, energy, velocity of light.

TABLE VII

Chemical Measurands

BIOLOGICAL MECHANISM CHEMICAL COMPOSITION CHEMICAL REACTION CHEMICAL REACTION RATE CHEMICAL STATE CHEMICAL CONCENTRATION CONCENTRATION, GAS CONCENTRATION, IONIC CONCENTRATION, NO CONCENTRATION, NO CONCENTRATION, SALT CONCENTRATION, SALT CONCENTRATION, VAPOR CRYSTALLIZATION DIFFUSION RATE GAS, SAMPLE HUMIDITY OXIDATION SOLUBILITY, GAS

The physical quantities serving as nuclear measurands for the transduction and modification principles of the next chapter are listed in Table VIII. For a complete listing, see Appendix G.

TABLE VIII Nuclear Measurands

BOMBARDMENT, NUCLEAR FREQUENCY, ELECTROMAGNETIC RADIATION, GAMMA RAY RADIATION, IONIZING RADIATION, NUCLEAR RADIATION, X-RAY

IV. TRANSDUCTION AND MODIFICATION ELEMENTS

A. THE TRANSDUCTION MATRIX

Transduction is the process by which one form of energy is converted into another form of energy. Likewise, modification is the process by which one form of energy is changed to a like form of energy. In this section, the known transduction and modification principles are identified. These principles are the transduction and modification elements which make up the transduction path of a solid state sensor.

One way to represent these transduction and modification elements is in matrix form. A symmetric 7 X 7 matrix with rows and columns corresponding to the seven forms of energy is sufficient to illustrate all possible transduction and modification elements. The rows of the matrix represent the energy form of the input measurand while the columns represent the energy form of the output measurand. the matrix is symmetric, the diagonal blocks represent modification elements as the output energy form is the same as the input energy form. Likewise, the off-diagonal blocks represent transduction elements as the output energy form is different from the input energy form. The transduction matrix is illustrated in Figure 4.1. In the next chapter, the elements of this matrix will form the basis of the transduction path method of analysis, resulting in the development of the "transduction path diagram".

B. THE MATRIX ELEMENTS

The transduction matrix in Figure 4.1 serves to show how the transduction and modification elements may be organized

				(DUTPUT	r	- 11111	
		NUCL	СНЕМ	OPTI	MAGN	THER	месн	ELEC
	NUCL							
	СНЕМ						!	
т	OPTI							
I N P U T	MAGN							
1	THER							
	месн							
	ELEC							·
	- -							

Figure 4.1 Transduction Matrix.

into a single structure. To show the detailed structure of the matrix, it is broken up into a series of tables, each listing the transduction and modification principles with a particular form of energy as the output. The first column of the table represents the energy form of the input measurand and ranges from nuclear through electrical. The last column of the table represents the energy form of the output measurand and does not change within the table. In

this manner, the table may be regarded as representing a column of the matrix in Figure 4.1.

In order to change from one energy form to another, it is necessary to employ some transduction or modification principle. The middle column of each table lists the transduction or modification principles that may be employed to make the designated change. For example, Table IX, entitled "Mechanical Output Elements", contains an entry in which the input energy form is magnetic and the output energy form is mechanical. The transduction principle that makes this transition possible is magnetostriction, so an entry to that effect is made in the middle column of the table.

The other entries in the tables are prepared in a similar manner. Where a particular transduction modification principle cannot be conveniently specified, the device performing the transduction or modification specified instead. For example, a bridge circuit commonly used as an electrical modifier in solid state sensors. Its operation is based upon several electronic principles, but there is little to gain by enumerating them separately. It is sufficient to know that a structure exists which will convert small changes in resistance to a usable voltage and is called a "Bridge Circuit". reader, upon seeing such an entry, would then refer to the appropriate literature for a full description of operation and theory of such a device.

No attempt is made in this paper to describe the theory behind the transduction and modification steps employed in the transduction path approach to solid state sensors. Of prime importance in this paper is to convey a method by which solid state sensors may be analyzed and investigated. However, to make it easier for the reader to utilize this method, an index of all the transduction and modification

principles is provided in Appendix H. Each principle is listed alphabetically, along with the associated input and output measurands. Additionally, an appropriate source for detailed information is indicated for each principle. Unless otherwise indicated, the source which may be consulted for further information on each principle is [Ref. 11].

1. Mechanical Output Elements

In this section, the transduction and modification principles which have a mechanical output measurand identified. Table IX contains a listing of those transduction and modification principles which represent blocks in the mechanical output column of the transduction By definition, those entries in Table IX with a matrix. mechanical input measurand are modification elements while all others are transduction elements. The modification elements do not change the energy form of the input measurand; in this case it remains in mechanical form. Rather than listing all of the known mechanical modifiers, only those with known applications in solid state sensors are included in Table IX.

A mechanical modification element that is utilized in many solid state sensors is "elastic deformation". This is a general term that may be applied to any structure or device that relies upon its elastic properties to modify mechanical energy. A common example of a device that utilizes this principle is a diaphragm which deforms in a predictable manner as a function of pressure. Many pressure transducers operate on this principle.

In the traditional generation of sensors, the elastic properties of metal were often relied upon for applications requiring elastic deformation. However, many such metal devices were subject to hysteresis in which the

prestressed behavior differed from the non-prestressed behavior. As noted earlier, silicon has proved to be a nearly ideal material for constructing solid state sensors. Being a monolithic material, silicon is very nearly free from the disadvantages of hysteresis. Furthermore, silicon is capable of being micromachined into various configurations through the process of chemical etching. Micromachining is the process by which extremely small structures may be fabricated and represents a great reduction in scale from the traditional generation of sensors which employed macromachining.

Since the ultimate goal of a solid state sensor is to convert a measurand into an electrical form of energy, the transduction and modification elements listed in Table IX represent only an intermediate step in the transduction path of a sensor. Further transduction would be necessary to finally arrive at a useful electrical output. As can be seen in Table IX, there are often several principles that may be utilized to transform a given form of energy into a mechanical form. In order to determine which of the transduction or modification elements may be useful for a particular application, the reader may refer to Appendix N for information on input and output measurands.

2. Thermal Output Elements

In this section, the transduction and modification principles which have a thermal output measurand are identified. Table X contains a listing of those transduction and modification principles which represent blocks in the thermal output column of the transduction matrix. By definition, those entries in Table X with a thermal input measurand are modification elements while all others are transduction elements. The modification elements do not change the energy form of the input measurand; in this case it remains in thermal form.

TABLE IX Mechanical Output Elements

INPUT FORM		PRINCIPLE	01	UTPUT FORM
Nuclear	*		*	Mechanical
Chemical	*	Atmolysis Capillary Column Chemisorption Jones Effect Osmosis Paramagnetism	*	Mechanical
Optical	*	Radiation Pressure	*	Mechanical
Magnetic	*	Einstein-de Hass Effect Magnetic Anisotropy Magnetic Sound Dispersion Magnetostriction	*	Mechanical
Thermal	*	Thermal Expansion	*	Mechanical
Mechanical	*	Acoustic Interference Acoustic Propagation Archimede's Principle Bauschinger Effect Cavitation Doppler (Acoustic) Elastic Deformation Elastic Limit Eotvos Effect Gravity Pendulum Hydrodynamic Element Lorentz Contraction Mechanical Resonance Poisson's Ratio Quartz Resonator Resonance Rotor Vibrating Wire Vortex Shedding	*	Mechanical
Electrical	*	Ampere's Law Electric Wind Effect Electroacoustic Electro-osmosis Electrostrictive Ferroelectric Interdigital Transducer Johnsen-Rahbek Effect Pinch Effect Winslow Effect	*	Mechanical

An element of the matrix that is particularly useful is that of "thermal conductivity". In existing sensors, this principle is used to measure air velocity, mass flow rate, flow velocity, chemical composition, and heat transfer It relies upon the concept of heat energy transfer. Several physical phenomena have an effect upon the manner in which heat is transferred and can thus be indirectly measured. For example, a solid state anemometer has been developed which operates by measuring the temperature of a heated element in contact with the airflow. The amount of heat that is transferred from the heated element to the airstream is dependent upon the thermal conductivity of air and the velocity of the airflow. Since the mathematical relationships are known, the air velocity may be calculated in an appropriate manner.

The transduction and modification elements listed in Table X represent only an intermediate step in the transduction path of a sensor since the output is not electrical in form. Further transduction would be necessary to finally arrive at a useful electrical output. As can be seen in Table X, there are often several principles that may be utilized to transform a given form of energy into thermal energy. In order to determine which of the transduction or modification elements may be useful for a particular application, the reader may refer to Appendix M for information on input and output measurands.

3. Electrical Output Elements

In this section, the transduction and modification principles which have an electrical output measurand are identified. Tables XI and XII contain listings of those transduction and modification principles which represent blocks in the electrical output column of the transduction matrix. This table is unique in that the output measurand

TABLE X
Thermal Output Elements

PRINCIPLE OUTPU'

Fission * The

INPUT FORM		PRINCIPLE	JO	JTPUT FORM
Nuclear	*	Fission	*	Thermal
Chemical	*	Combustion Electrolytic Dissociation Photoabsorption Thermal Conductivity	* 1	Thermal
Optical	*	Photoabsorption	*	Thermal
Magnetic	*	Thermomagnetic	*	Thermal
Thermal	*	Fourier's Law Righi-Leduc Effect Thermal Conductivity	*	Thermal
Mechanical	*	Craft's Rule Hot Wire Piezocaloric Thermal Conductivity	*	Thermal
Electrical	*	Benedick Effect Ettingshausen Effect Joule's Law Peltier Effect Spark Gap	*	Thermal
		Spark Gap		

is of a form suitable for output by a solid state sensor. These transduction and modification steps represent the final stage in a transduction path which must terminate in the electrical domain. By definition, those entries in Tables XI and XII with an electrical input measurand are modification elements while all others are transduction elements.

The electrical input measurand elements of Table XII do not change the form of energy from input to output. These are the modification elements, commonly referred to as

signal processing steps. The entire field of electronics may be considered to lie within the realm of electrical modifiers. Rather than attempt to list them all within this section, only those devices which have found particular applications in the field of solid state sensors are included.

Those entries in Tables XI and XII which are not modifiers are, of course, transduction elements. These are particularly useful for use in solid state sensors in that they represent a direct path to the electrical domain from a non-electrical measurand. They also serve as the terminal step in a transduction path which may utilize several transduction or modification elements as intermediate steps. By playing such an important role in the transduction path, these transduction and modification elements form the most important column in the transduction matrix.

As can be seen in Tables XI and XII, there are many transduction and modification principles which have an electrical output. This allows great flexibility in choosing the principles to be used in the design of a solid state sensor. However, only a few principles prove useful in a given application, so the reader is referred to Appendix O for information on input and output measurands.

4. Magnetic Output Elements

In this section, the transduction and modification principles which have a magnetic output measurand are identified. Table XIII contains a listing of those transduction and modification principles which represent blocks in the magnetic output column of the transduction matrix. By definition, those entries in Table XIII with a magnetic input measurand are modification elements while all others are transduction elements. The modification elements do not change the energy form of the input measurand; in

TABLE XI
Electrical Output Elements I

INPUT FORM		PRINCIPLE	OUTPUT FORM
Nuclear	*	Fission Joshi Effect Photoconductive Photoemissive Photovoltaic PIN Photocurrent	* Electrical
Chemical	*	Cathodic Reduction Chemisorption Electrochemical Gate Controlled Diode Hygroscopic Salt ISFET Kohlrausch's Law Polymer PAPA Triboelectricity Variable Dielectric Zirconium Oxide Cell	* Electrical
Optical	*	APD Becquerel Effect CCD Hallwock's Effect Hertz Effect Josephson Junction Photoconductance Photoemissive Photovoltaic PIN Photocurrent	* Electrical
Magnetic	*	Corbino Effect Faraday Induction Galvanomagnetic (Hall) Gauss Effect Josephson Junction Magnetoresistance Sensing Coil Variable Permeability	* Electrical
Thermal	*	Edison Effect Josephson Junction Mattheissen's Rule Nernst Effect PTAT Pyroelectric TCD Thermoconductance Thermoelectric (Seebeck) Thermoresistance Thermovoltaic Junction Variable Dielectric Workman-Reynolds Effect	* Electrical

this case it remains in magnetic form. Relatively few principles with a magnetic output are known. However, most of these are transduction principles with the most common input energy form being mechanical.

Two magnetic modification elements are listed in Table XIII and the rest are transduction elements. the ultimate goal of a solid state sensor is to convert a measurand into an electrical form of energy, the transduction and modification elements listed in Table IX represent only an intermediate step in the transduction path of a sensor. Some other transduction element must follow in the transduction path if an electrical output is to realized. Table XI contains six transduction principles which lead from a magnetic input to an electrical output. These represent six possible paths which may lead from a magnetic signal to a useful electrical signal. As will be illustrated in a subsequent chapter, many other possible paths exist as well.

The magnetic output principles are currently being used quite heavily in the field of automotive engine control sensors. Most use has been made of the Wiegand Effect and the Inductive Eddy Current Effect in this field. Another very useful principle is magnetostriction, which converts a mechanical strain into a magnetic field. Magnetostriction is also capable of converting a magnetic field into a mechanical strain. For this reason, magnetostriction appears in Table IX as well. Several other effects also exhibit this property of being reversible.

As can be seen in Table XIII, sometimes there are several principles which may be utilized to transform a given form of energy into magnetic energy. In order to determine which of the transduction or modification elements may be useful for a particular application, the reader may refer to Appendix L for information on input and output measurands.

TABLE XII

Electrical Output Elements II

INPUT FORM	PRINCIPLE	OUTPUT FORM
Mechanical *	Acoustoelectric Conductive Elastomer Doppler (Electric) Dorn Effect (Electrokine Interdigital Transducer Ion Movement Mechanical Switch Oscillator Piezoelectric Piezo-optical Effect Piezoresistance PN Piezojunction Potentiometric Proximity Effect Resistance-Pressure Effe Thermoelastic Effect Variable Conductivity Variable Dielectric Variable Reluctance Wertheim Effect	•
Electrical *	Bridge Circuit Capacitive PI-FET CFT Charge Amplifier Charge Mobility Differential Transforme: ECKO ECOLD Electro-optical Effect Gate Controlled Diode Impedance Induction ISFET Josephson Junction MOS Capacitor Ohm's Law Oscillator Phase Shift Oscillator Phase Shift Oscillator PIN PLL Power Law Quantum Interferometer Sensing Coil Signal Processing Spark Gap (Paschen's Law Unijunction Oscillator Varistor Wien Effect Zener Effect	

TA	ABLE XI	II
Magnetic	Output	Elements

INPUT FORM		PRINCIPLE	OUTPUT FORM
Nuclear	* 	Fission	* Magnetic
Chemical	*		* Magnetic
Optical	*	Photomagnetic Effect	* Magnetic
Magnetic	*	Barkhausen Effect Wiegand Effect	* Magnetic
Thermal	*	Curie-Weiss Law	* Magnetic
Mechanical	*	Barnett Effect Doppler (Magnetic) Flux Density Inductive Eddy Current Magnetostriction Villari Effect	* Magnetic
Electrical	*	Faraday Induction	* Magnetic

5. Optical Output Elements

In this section, the transduction and modification principles which have an optical output measurand are identified. Tables XIV and XV contain listings of those transduction and modification principles which represent blocks in the optical output column of the transduction matrix. By definition, those entries in Tables XIV and XV with an optical input measurand are modification elements while all others are transduction elements. The modification elements do not change the energy form of the input measurand; in this case it remains in optical form. The entire field of optics may be considered to lie within

the realm of optical modifiers. Rather than attempting to list all of the known optical modifiers, only those with known applications in solid state sensors are included in Table XIV.

Many transduction and modification principles known which have an optical output. One of the optical modifiers which is finding increasing application in field of solid state sensors is the optical fiber. the wavelength of light is on the order of micrometers, can be used to measure very small physical changes with good resolution. Extremely sensitive detectors have been developed which make possible the detection of very small changes in the light propagation characteristics of an optical fiber. Furthermore, advances in materials processing have led to optical fibers of unprecedented These factors combine to make uniformity and purity. optical fibers excellent distributed sensing elements of great sensitivity. Already, they have seen use in magnetometers and optical gyroscopes.

The development of the laser has likewise had a large impact on the field of solid state sensors. A laser resonant cavity is extremely sensitive to changes in physical dimension and as such makes a good sensing element with extremely good resolution. The development of the laser diode has likewise opened new possibilities for optical systems in solid state sensing. Small and reliable, they bring optics into the solid state age.

Since the ultimate goal of a solid state sensor is to convert a measurand into an electrical form of energy, the transduction and modification elements listed in Tables XIV and XV represent only an intermediate step in the transduction path of a sensor. Further transduction would be necessary to finally arrive at a useful electrical output. A fairly wide choice of optical principles with an

electrical output are available in Tables XIV and XV. In order to determine which of the transduction or modification elements may be useful for a particular application, the reader may refer to Appendix K for information on input and output measurands.

	TABLE XIV	
	Optical Output Eleme	ents I
INPUT FORM	PRINCIPLE	OUTPUT FORM
Nuclear	 Cerenkov Effect Fission Geiger Effect Luminescence Radiation Darkenin 	* Optical
Chemical	* Absorption (Lamber Bioluminescence Combustion Crystalluminescence Lambert's Law Optical Rotation Variable Density	
Optical	* Amplitude Modulati Brewster's Law Christiansen Effect Color Mixing Lens System Luminescence NTIR Phase Interferomet Photoluminescence Snell's Law Variable Reflectiv	et
Magnetic	* Faraday Rotation Kerr Magneto-optic Liquid Crystal Luminescence	* Optical Effect

	TABLE	XV	
Optical	Output	Elements	ΙI

		optical output blements if	
INPUT FORM		PRINCIPLE	OUTPUT FORM
Thermal	*	Blackbody Radiation Energy Bandgap Shift Gladstone & Dale's Law Incandescence Liquid Crystal Mirage Effect Stefan-Boltzmann Law Thermo-optic Wien's Displacement Law	* Optical
Mechanical	*	Absorption Coulomb's Law Diffraction Diffraction Doppler (Optical) Elasto-optic Effect Evanescence FTIR Gladstone & Dale's Law Interference Coating Lambert's Cosine Law Lambert's Law Laser External Mirror Numerical Aperture Optical Interference Photoelastic Effect Piezo-optical Effect Radiative Losses Sagnac Phase Shift Schlieren Grating Sonoluminescence Triboluminescence Variable Birefringence Variable Refractive Index	* Optical
Electrical	*	Cerenkov Effect Electroluminescence Electro-optical Effect Kerr Effect LED Electro-optic Luminescence Stark Effect	* Optical

6. Chemical Output Elements

In this section, the transduction and modification principles are identified which yield a chemical output

Table XVI contains a listing of those measurand. transduction and modification principles which represent blocks in the chemical output column of the transduction By definition, those entries in Table XVI with a chemical input measurand are modification elements while all others are transduction elements. The modification elements do not change the energy form of the input measurand; this case it remains in chemical form. Most of the field of chemistry may be considered to lie within the realm of chemical modifiers. Rather than attempting to list all of the known chemical modifiers or chemical reactions, only those with known applications in solid state sensors are included in Table XVI.

The principles of modern chemistry that have seen implementation in solid state sensors are relatively few in number considering the vast bulk of knowledge available on chemical processes. Chemical sensors are exposed an environment that is often damaging to associated integrated circuitry. For this reason, the problem of sensor sealing has received a great deal of attention. The ideal solid state chemical sensor would have a sensing element fully exposed to the chemical reaction undergoing measurement while still providing protection to the delicate electronic circuitry.

Since the ultimate goal of a solid state sensor is to convert a measurand into an electrical form of energy, the transduction and modification elements listed in Table XVI represent only an intermediate step in the transduction path of a sensor. Further transduction would be necessary to finally arrive at a useful electrical output. For example, the photochemical processes employed in black and white photography convert an optical image into a chemical reaction on the photographic film. The information stored in the chemical state of the film is not immediately useful

as an output since it is not electrical in nature. The chemical state is, however, available as an optical signal since the chemical state determines the opacity of the film. This optical signal may then be converted into an electrical signal through an appropriate application of a photoelectric effect.

As can be seen in Table XVI, there is occasionally more than one principle that may be utilized to transform a given form of energy into chemical energy. Therefore, the reader is referred to Appendix J for information on input and output measurands.

		TABLE XVI		
		Chemical Output Element	CS	
INPUT FORM		PRINCIPLE	OUTPUT FO	RM
Nuclear	*		* Chemica	.1
Chemical	*	Adsorption Donnan Membrane Equil:	* Chemica ibrium	.1
Optical	*	Photochemical Photosynthesis	* Chemica	.1
Magnetic	*		* Chemica	.1
Thermal	*	Arrhenius Equation Henry's Law	* Chemica	.1
Mechanical	*		* Chemica	.1
Electrical	*	Electroplating	* Chemica	1

7. Nuclear Output Elements

In this section, the transduction and modification principles which have a nuclear output measurand are identified. Table XVII contains a listing of those transduction and modification principles which represent blocks in the nuclear output column of the transduction matrix. By definition, those entries in Table XVII with a nuclear input measurand are modification elements while all others are transduction elements. The modification elements do not change the energy form of the input measurand; in this case it remains in nuclear form.

The field of nuclear physics has long been a very specialized field with very specialized instrumentation. However, the demand for low cost, reliable sensing devices has grown in recent years. Spacecraft designers, physicists, the nuclear industry, medical researchers, and the military represent a growing number of users with applications for such devices.

Since the ultimate goal of a solid state sensor is to convert a measurand into an electrical form of energy. the transduction and modification elements listed in Table XVII represent only an intermediate step in the transduction path of a sensor. Further transduction would be necessary to finally arrive at a useful electrical output. It can be seen in Table XVII that the number of useful principles with a nuclear output is rather small. However, due to the particularly energetic and dangerous qualities of nuclear output measurands, it is unlikely that the principles listed in Table XVII will see widespread application. determine which of the transduction or modification elements may be useful for a particular application, reader may refer to Appendix I for information on input and output measurands.

TABLE XVII Nuclear Output Elements

INPUT FORM		PRINCIPLE	OUTPUT FORM
Nuclear	*	Fission	* Nuclear
Chemical	*		* Nuclear
Optical	*		* Nuclear
Magnetic	*		* Nuclear
Thermal	*		* Nuclear
Mechanical	*	Doppler (Nuclear)	* Nuclear
Electrical	*	Bremstrahlung Radiation	* Nuclear

V. THE TRANSDUCTION PATH METHOD

A. DESCRIPTION

The purpose of a solid state sensor is to convert an input measurand to an electrical output signal. The input measurand is manifested as a signal belonging to one of seven different forms of energy. When this signal is other than electrical in nature, it must undergo the process of transduction before it can be processed by electronic devices.

This process of transduction may be described through what is now referred to as the "transduction path" method. The method defines a transduction path as a sequence of individual transduction or modification principles which lead from an input measurand to an electrical output signal. While some transducers employ only a single transduction or modification principle, many transducers are multi-step devices which employ several principles for their operation.

For example, a typical pressure transducer is a two step device which utilizes the principles of elastic deformation and piezoresistance. Elastic deformation modifies the mechanical input measurand, pressure, into a mechanical output measurand, strain. This strain is in turn applied as a mechanical input measurand to a piezoresistive device which transduces it to a change in electrical resistance. The transduction path of this sensor would consist of a modification principle, elastic deformation, followed by a transduction principle, piezoresistance.

An example of a single step device is the thermocouple. It operates on the thermoelectric effect and transduces a thermal input measurand, temperature, directly to an

electrical output signal, voltage. The transduction path of this sensor would consist of only a single transduction principle, the thermoelectric effect.

As can be seen in the preceding examples, the transduction path may consist of one or more discrete transduction or modification steps. A requirement in all cases, however, is that the final step of the transduction path must yield an electrical output measurand. Also, in a multiple step transduction path, the output and input measurands of consecutive steps must be the same.

The transduction path method represents a means of describing the operation of a solid state sensor. However, it requires knowledge of transduction and modification principles drawn from all fields of science. It is for this reason that the known transduction and modification principles are tabulated in Appendix H for easy reference.

The transduction matrix of Figure 4.1 represents a means through which transduction and modification principles may be grouped in an orderly fashion. Each block represents a family of either transduction or modification principles with associated input and output energy forms. Blocks on the diagonal are modification elements while blocks off the diagonal are transduction elements.

In Chapter IV, the known transduction and modification principles were identified by family in Tables IX through The number of principles belonging to each family, based on input-output energy forms, is annotated in Figure The number in each block represents the number of 5.1. known principles which make that particular transduction or modification possible. For example, XI contains ten principles which permit the transduction of optical energy to electrical energy. Accordingly, a 10 is entered in the block of Figure 5.1 which lies at intersection of the optical input row and the electrical

output column. Empty blocks in Figure 5.1 indicate that no principle is known which permits that particular transduction or modification of energy.

NUCL CHEM OPTI MAGN THER MECH ELEC NUCL 1		OUTPUT								
CHEM 2 7 4 6 11			NUCL	СНЕМ	OPTI	MAGN	THER	месн	ELEC	
OPTI 2 11 1 1 1 10 1 N P MAGN 4 2 1 4 8 T THER 2 9 1 3 1 13 MECH 1 24 6 4 19 20		NUCL	1		5	1	1		6	
N		СНЕМ		2	7		4	6	11	
THER 2 9 1 3 1 13	т	OPTI		2	11	1	1	1	10	
THER 2 9 1 3 1 13	N P U	MAGN			4	2	1	4	8	
	1	THER		2	9	1	3	1	1.3	
ELEC 1 1 7 1 5 11 28		месн	1		24	6	4	19	20	
		ELEC	1	1	7	1	5	11	28	

Figure 5.1 Distribution of Principles.

The transduction path method represents a general concept which may be utilized to describe the operation of a solid state sensor. However, a framework is necessary if the method is to be utilized effectively. As will be seen

in the next section, the "transduction path diagram" provides just such a framework.

B. THE TRANSDUCTION PATH DIAGRAM

Conceptually, the transduction path of a sensor consists of a sequence of individual transduction or modification principles which lead from an input measurand to an electrical output signal. In this section, a structure is developed which is able to present the transduction path of a solid state sensor in graphical form.

Representing a refinement of the transduction matrix introduced in Chapter IV, the structure shown in Figure 5.2 has several important properties. Most important of these properties is that this structure, hereafter referred to as the "transduction path diagram", is capable of providing a graphical illustration of a transduction path. This diagram interconnects all of the known transduction and modification principles in a systematic and orderly fashion. capable of not only describing the operation of sensors, but may also serve to illustrate how a sensor can be susceptible to undesirable, secondary measurands that may inhibit its accuracy. Finally, it may also serve as a mechanism for the systematic investigation of sensor configurations.

At first glance, the diagram appears similar to the transduction matrix introduced in Chapter IV. Both are arranged about a symmetric 7 X 7 matrix with energy form labels on the rows and columns. Similarity to the transduction matrix ends at this point, however. In the transduction matrix, the rows represented the input energy form and the columns represented the output energy form. However, in the transduction path diagram, a different approach is taken. The input/output distinction is made in

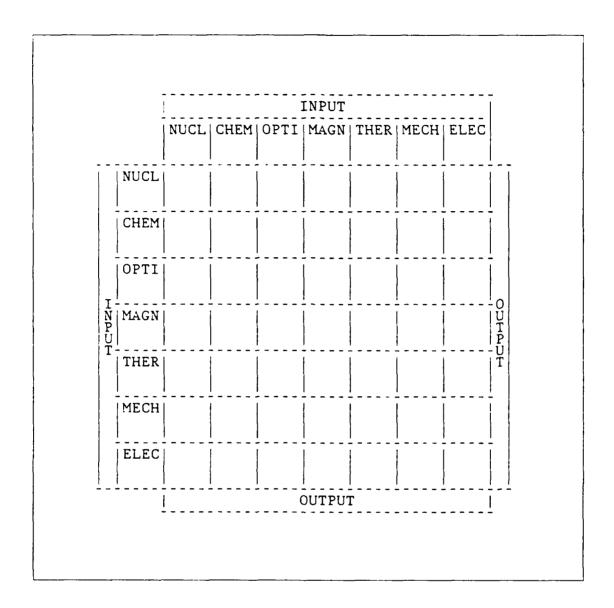


Figure 5.2 Transduction Path Diagram.

an entirely different manner as will be explained later in this section.

In order to show how the transduction path diagram operates, it is best broken down into three main sections. These are the input section, the transduction path section, and the output section.

1. <u>Input Section</u>

On the top and left side of the transduction path diagram are boxes, each containing a label indicating one of the seven forms of energy. These fourteen boxes represent the input measurand of a solid state sensor. Since every transduction path starts with an input measurand, these boxes also represent the fourteen possible points of origin of a transduction path. To remind the user of this fact, adjacent to these boxes are long, narrow, blocked-in areas labelled "INPUT". This particular portion of the transduction path diagram is illustrated in Figure 5.3.

2. Transduction Path Section

The body of the transduction path diagram is a 7 X 7 matrix which is used to illustrate the transduction and modification steps utilized in a solid state sensor. A transduction path begins with an input measurand and consists of a sequence of one or more transduction or modification steps. Each of these steps has an associated input and output measurand. The labels on the rows and columns of this portion of the diagram serve to identify the energy form of these measurands. A few observations are necessary to determine whether these labels should be read to indicate input or output and are described below.

Transduction and modification steps are indicated by lines which lie within a single row or column. A line lies within the row or column that has the same energy form as its input measurand. This same line terminates in the perpendicular row or column that has the same energy form as its output measurand.

This particular portion of the transduction path diagram is illustrated in Figure 5.4.

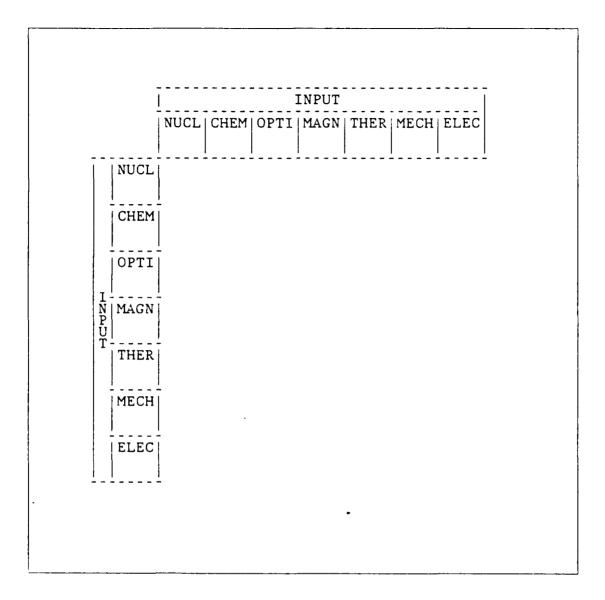


Figure 5.3 Input Measurand Section.

3. Output Section

On the bottom and right side of the transduction path diagram are thirteen boxes lying within the row and column labelled "ELEC". Adjacent to these thirteen boxes are long, narrow, blocked-in areas labelled "OUTPUT". These thirteen boxes also appear in the transduction path section

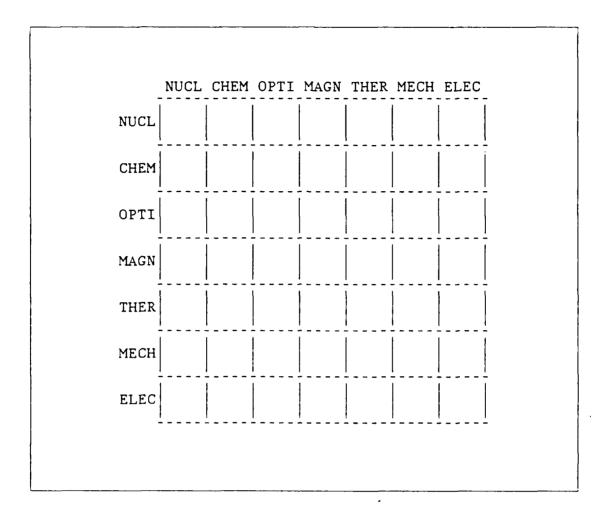


Figure 5.4 Transduction Path Section.

of the diagram, but have a special significance which must be mentioned here.

The box in the bottom right corner which lies both within the electrical row and the electrical column may be entered only through an electrical modification step. The other twelve boxes may be entered only through a transduction step which yields an electrical output. Since the end result of the transduction path of a solid state sensor is an electrical output signal, a transduction path could legitimately terminate in any of these thirteen boxes.

many transduction principles yield an However. electrical output that is not in a readily usable form. Typically, some signal processing or conditioning is necessary in order to obtain an electrical signal significant strength and fidelity. Therefore. transduction path that terminates in one of the twelve boxes mentioned above may be extended by one more step. This step would involve electronic signal processing and would result in a transduction path which ends in the bottom right box of the diagram. While any of the thirteen output boxes are legitimate termination points, the bottom right box is the preferred termination point. This particular portion of the transduction path diagram is illustrated in Figure 5.5.

C. A SAMPLE ANALYSIS

Earlier in this chapter, a pressure transducer was given as an example of a two step device. It utilized the principles of elastic deformation and piezoresistance to convert an input measurand, pressure, into an electrical output signal, resistance.

By referring to the tables of measurands in Chapter III, it can be seen that pressure is classified as a mechanical measurand. Therefore, the transduction path has a mechanical input measurand and will originate in an input block labelled "MECH", either at the top or left side of the diagram. Since the diagram is symmetric, these two blocks are equivalent and it is unimportant which of the two is actually chosen. However, to set a convention, assume that the block on the left side of the diagram is chosen to be the point of origin. Since the steps of the transduction path will be numbered as the example proceeds, a "O" is placed in the indicated block.

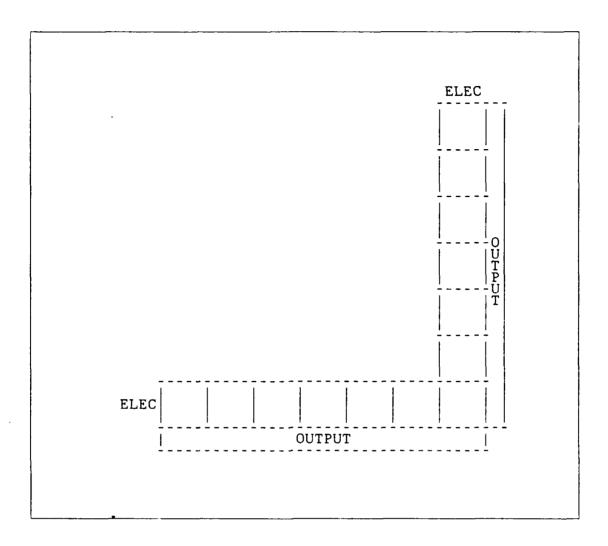


Figure 5.5 Output Signal Section.

The transduction path of a sensor consists of a sequence of transduction or modification principles. The example pressure transducer described above is a two step device which utilizes the principles of elastic deformation and piezoresistance. Elastic deformation modifies the mechanical input measurand, pressure, into a mechanical output measurand, strain. This strain is in turn applied as a mechanical input measurand to a piezoresistive device which transduces it to a change in electrical resistance.

The transduction path of this sensor would consist of a modification principle, elastic deformation, followed by a transduction principle, piezoresistance.

The point of origin for the transduction was selected previously to be on the left side of the diagram in the mechanical row. This initially specifies the rows to be input energy forms and the columns to be output energy forms.

The first step of the transduction path is a principle known as elastic deformation. By referring to the tables in Chapter IV and the appropriate entry in Appendix N, elastic deformation is seen that а modification principle. Therefore, a line is drawn from the point of origin along the row labelled "MECH", terminated in the block which lies in the output column labelled "MECH". In order to continue the numbering of the steps, a "1" is placed in this block. It is significant to note that this block lies on the diagonal transduction path diagram. It will be noted that modification steps terminate in a block lying on diagonal.

The second step of the transduction path is a principle known as piezoresistance. By referring to the tables in Chapter IV and the appropriate entry in Appendix O, it can be seen that piezoresistance is a mechanical to electrical transduction principle. The output energy form from the previous step of the transduction path becomes the input energy form for the current transduction step. This changes the input/output meaning of the rows and columns. The column labelled "MECH" is now the input energy form and the output energy form will be specified by the row designation. Therefore, a line is drawn from the ending point of the first step, along the column labelled "MECH", to be terminated in the block which lies in the output row

labelled "ELEC". A "2" is placed in this block to continue the numbering scheme.

The final step necessary to complete the transduction path diagram is to ensure that a legitimate output signal is available. By definition, all solid state sensors must have an electrical output signal. This general requirement has been satisfied, for the path does indeed terminate in an electrical output row. However, the electrical signal being provided at the output is a very small change in resistance. This must be further processed to generate a signal that may be digitized and assimilated by a microprocessor or controller.

To accomplish this, an electrical modification step is appended to the transduction path. A Bridge Circuit would be a suitable electrical modifier to convert a small change in resistance to a usable output voltage. Therefore, a line is drawn from the termination of the previous step, the electrical row, to terminate in the bottom right block of the transduction diagram. To finish the step numbering scheme, a "3" is entered in this block. This indicates that the transducer is actually a three step device when signal processing is included. Inclusion of the final electrical modification step is optional, but recommended in the majority of cases. Figure 5.6 shows the completed transduction path diagram with step numbers, measurands, and principles noted below the diagram.

The roles of the row and column labels alternate with each transduction or modification step. A transduction path with an even number of steps will end in a row if it begins in a row. Likewise, a transduction path with an even number of steps will end in a column if it begins in a column. In a similar manner, a three step transduction path which begins in an input row would terminate in an output column. Due to the symmetric nature of the diagram, similar results would be noted for any length odd or even transduction path.

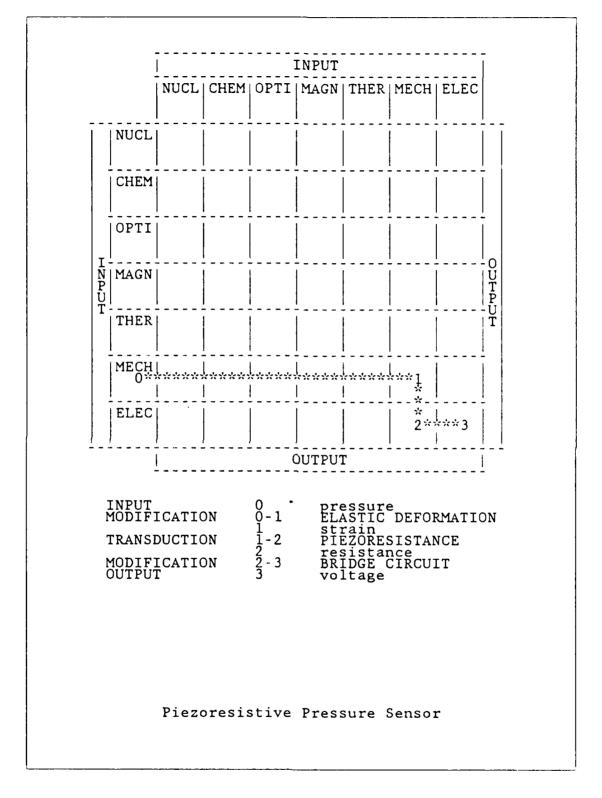


Figure 5.6 A Sample Three Step Transduction Path.

D. EXISTING TRANSDUCERS

The example presented above illustrates the general procedure to be followed when using the transduction path diagram as a method of sensor analysis. The transducer described may be regarded as being representative of a broad class of piezoresistive pressure transducers. However, the true test of the transduction path method lies in its ability to describe the widest range and variety of existing transducers.

In order to extensively test the transduction path method, information was collected on 108 different classes of sensors and transducers. This information was available in the form of articles from technical journals and specification sheets from manufacturers. The transduction path of each sensor was then determined and examined for compatibility with the transduction path diagram. The sensors examined were found to range from simple one step transduction paths to extremely complex seven step transduction paths. Each was found to be compatible with the transduction path method.

Due to the large number of sensors examined using this method, it is not practical to attempt to present all of the transduction paths here. Instead, one existing sensor has been chosen to represent each length of transduction path. In the sections below, a short description of each representative sensor is presented along with a completed transduction path diagram describing that sensor.

1. One Step

A representative example of a transducer with a one step transduction path is the Bridge Circuit, often referred to as a Wheatstone Bridge. It converts a small resistance change in one of its legs into a voltage which may be easily measured. This one step transduction path is illustrated in Figure 5.7.

This transducer, consisting of only a single step, illustrates the shortest transduction path possible. It is interesting to note that since a transduction path is required to terminate in the lower right block of the diagram, a single step transduction path must consist of an electrical modifier.

2. Two Step

A representative example of a transducer with a two step transduction path is the Solid State Thermistor. It converts the input measurand, temperature, into an electrical output signal which may be interfaced to digital circuitry. The two step transduction path of this device is illustrated in Figure 5.8.

The operation of the semiconductor thermistor is based on the thermoresistive effect. It is used primarily to measure temperature and has several advantages over the traditional generation of temperature sensors. These advantages include high temperature coefficient, small dimensions, and fast response. The high temperature coefficient eliminates many of the difficulties usually encountered when attempting to process the raw electrical output signal from the thermoresistance step. [Ref. 12]

This transduction path consists of two individual steps, a transduction followed by a modification. As noted earlier, the last step of a transduction path is required to be an electrical modifier. A Bridge Circuit is specified as the last step in this transduction path, but some other electrical modifier may serve just as well.

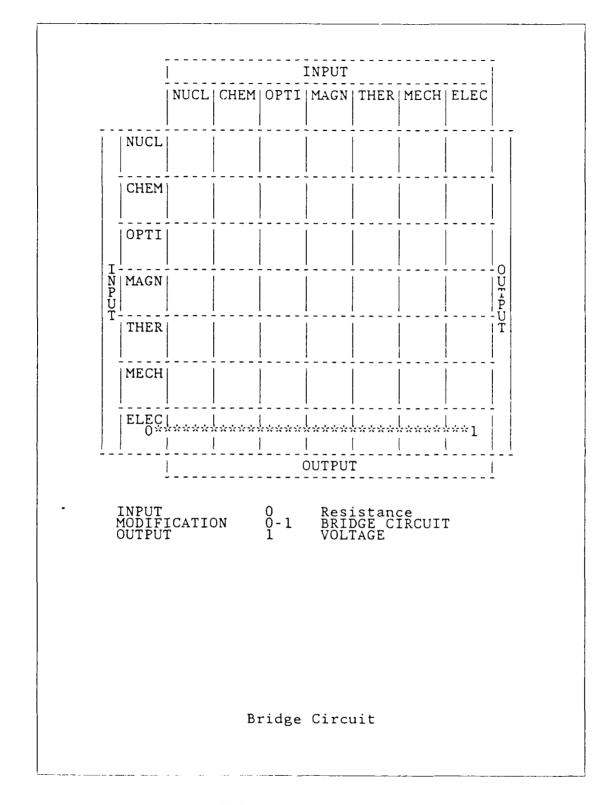


Figure 5.7 One Step Transducer.

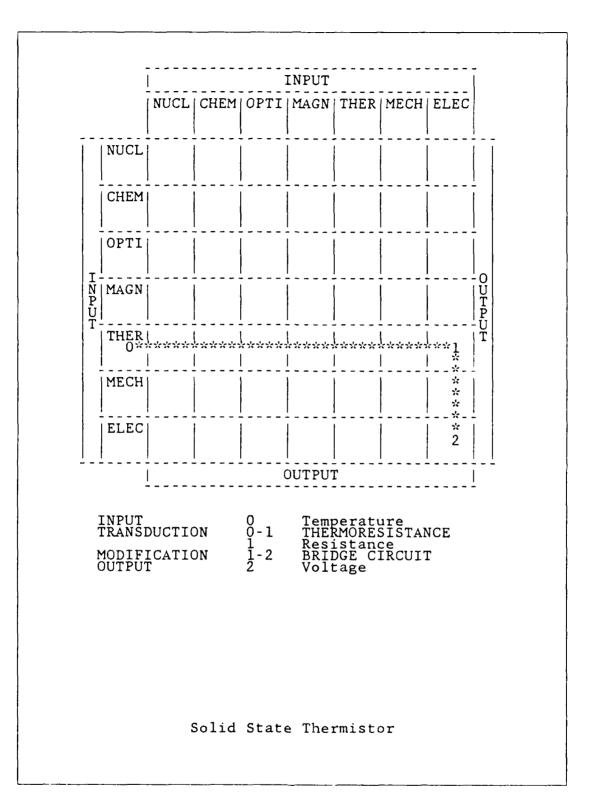


Figure 5.8 Two Step Transducer.

3. Three Step

A representative example of a transducer with a three step transduction path is the Integrated Silicon Microbeam. PI-FET Accelerometer. It converts the input measurand, acceleration, into an electrical output signal. The three step transduction path of this device is illustrated in Figure 5.9.

The operation of the Integrated Silicon Microbeam PI-FET Accelerometer is based on the piezoelectric effect and the principle of elastic deformation. It is fabricated utilizing silicon planar technology, zinc-oxide sputtering, and anisotropic etching. A small cantilever beam is etched out of monolithic silicon and coated with a piezoelectric film. When the device undergoes acceleration, the cantilever beam flexes as does the piezoelectric coating. This creates a surface charge on the piezoelectric film. Due to careful isolation of the piezoelectric film from electrical leakage paths, a near-dc response is achieved up to 40 kHz. [Ref. 13]

This transduction path consists of three individual steps. The first is a modification, the second is a transduction, and the third is an electrical modifier. In this case, the last step is a PI-FET structure which converts charge to an amplified output voltage. The surface charge induced on the piezoelectric material is capacitively coupled to the gate of the p-channel, depletion mode FET with an amplified signal appearing at the drain [Ref. 13].

4. Four Step

A representative example of a transducer with a four step transduction path is the Wiegand Pulse Generator, often used in automotive engine control applications. It converts the input measurand, vane position, into an electrical

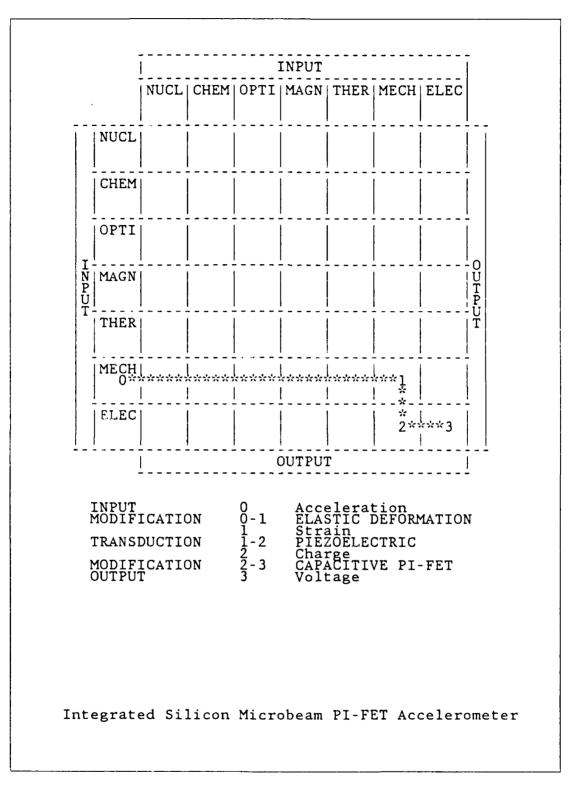


Figure 5.9 Three Step Transducer.

output signal. The four step transduction path of this device is illustrated in Figure 5.10.

The Wiegand Effect is a magnetic phenomenon which occurs in a specially work-hardened small diameter ferro-magnetic wire. When a properly shaped magnetic field is applied, the Wiegand Wire acts as a bi-stable magnetic device. It changes from one magnetic state to the other by means of a rapid internal flux change. This flux change may be used to induce a quite substantial voltage in a nearby sensing coil. A particular feature worth noting is that the Wiegand Wire does not require an electrical input for its operation. [Ref. 14]

The Wiegand Pulse Generator operates upon the Wiegand Effect and the principles of variable reluctance and Faraday induction. The position of a soft-magnetic rotating vane influences the magnetic field of a permanent magnet through the principle of variable reluctance. The magnetic field is converted to a rapid flux change by the Wiegand Wire. This flux change is then used to induce a voltage in a sensing coil through the process of Faraday induction.

The transduction path of this device consists of four individual steps. These are, in order, a transduction, a modification, a transduction, and an electrical modifier. In this case, the last step is not specified beyond the general term, signal processing. The output of the sensing coil has been observed to range anywhere between one-half and ten volts [Ref. 14]. Therefore, the signal processing may consist of amplification, analog to digital conversion, or some other suitable electrical modifier.

5. Five Step

A representative example of a transducer with a five step transduction path is the Fiber Optic Magnetic Field Sensor. It converts the input measurand, magnetic field,

	<u> </u>	 		- 	INPUT	. 	- 		
		NUCL	CHEM	OPTI	MAGN	THER	MECH	ELEC	
	NUCL	<u></u> . 	<u></u> .	<u></u>		<u></u> - 			<u>-</u>
•	CHEM	 		<u> </u> 	<u> </u>	 		 	<u>-</u>
-	OPTI	<u> </u> 	 	 		 · 	 		<u>-</u>
I N P U	MAGN	<u></u> 	 	<u>-</u>	2**	 ******	 ******	 ***3	- OUTPU
Ĭ.	THER	<u> </u>		<u> </u>	* * *	<u> </u>			-Ū
•	MECH 0*	 	 *******	<u> </u> *******	 * ***1	<u> </u>			<u>-</u>
	ELEC	<u>.</u> 		<u>-</u>				*- 	<u>-</u>
	<u></u>	<u> </u>			DUTPUT	:		 	<u> </u>
	10DIF TRANSI	OUCTIO ICATIO OUCTIO ICATIO	N N	0 - 1 1 - 2 2 - 3 3 - 4	VARI Magg WIEC FAR Emf SIG	c Char ADAY :	Field EFFECT	CION	E
		,	√iegaı	nd Pul	lse Ge	enerai	tor		

Figure 5.10 Four Step Transducer.

into an electrical output signal. The five step transduction path of this device is illustrated in Figure 5.11.

The operation of the Fiber Optic Magnetic Field is based on the elasto-optic effect, the phase interferometer, and the principles of magnetostriction and photoconductance. The main principle by which this sensor operates is magnetostriction. An optical fiber is jacketed by a magnetostrictive material which produces a longitudinal strain when exposed to a magnetic field. induces a refractive index change in the optical fiber due to the elasto-optic effect. The refractive index change affects the manner in which light is propagated through the fiber and may be detected through the use of a phase The phase interferometer has an optical interferometer. power output which is allowed to fall upon a photoconductive This photoconductive device converts the incident optical power to a change in electrical resistance. [Ref. 15]

This transduction path consists of five individual transduction and modification principles, the last of which must be an electrical modifier. In this case, the last step is not specified beyond the general term, signal processing. The signal processing may consist of a Bridge Circuit or some other suitable electrical modifier capable of converting a change in resistance to voltage.

6. Six Step

A representative example of a transducer with a six step transduction path is the Laser Diode Current Sensor. It converts the input measurand, current, into an electrical output signal. An important advantage of this sensor is that the current sensing is accomplished in a non-contacting manner. The six step transduction path of this device is illustrated in Figure 5.12.

		NUCL	CHEM	OPTI	MAGN	THER	MECH	ELEC	
	NUCL	<u></u> -	<u> </u>		<u> </u>	<u> </u>	<u></u> -	<u>!</u>	<u> </u>
_	CHEM	 	<u> </u> 	 	 	<u> </u> 	 	<u> </u> 	<u> </u>
	OPTI	<u> </u>	 	3**	 	 *******	 ***2 *		<u> </u>
NPU	MAGN	 ******	- ******	*- * *****	<u>-</u>	<u>.</u> 	*- * ***1		OUTPU
Ť	THER	<u>-</u> 	<u>-</u> 	* * *	<u> </u>	<u>-</u> 	<u></u>		Ţ
-	MECH	<u> </u>		* * * *	! · 	<u> </u>	 		-
	ELEC	<u></u>	-	*- * 4*:	 	 *******	 ******	! ***5	-
		<u>-</u> 			UTPU	<u>'</u>	<u>.</u>	<u>-</u>	<u> </u>
7 7 1 1	TRANSI 10DIF TRANSI	DUCTIO DUCTIO ICATIO DUCTIO ICATIO	NC NC	0 - 1 1 - 2 2 - 3 3 - 4 5	Stra ELAS Refi PHAS Opti	STO-OI ractiv SE INT ical I TOCONI istand	PTIC I Ve Ind TERFEI Power OUCTIV	EFFECT dex ROMETI	

Figure 5.11 Five Step Transducer.

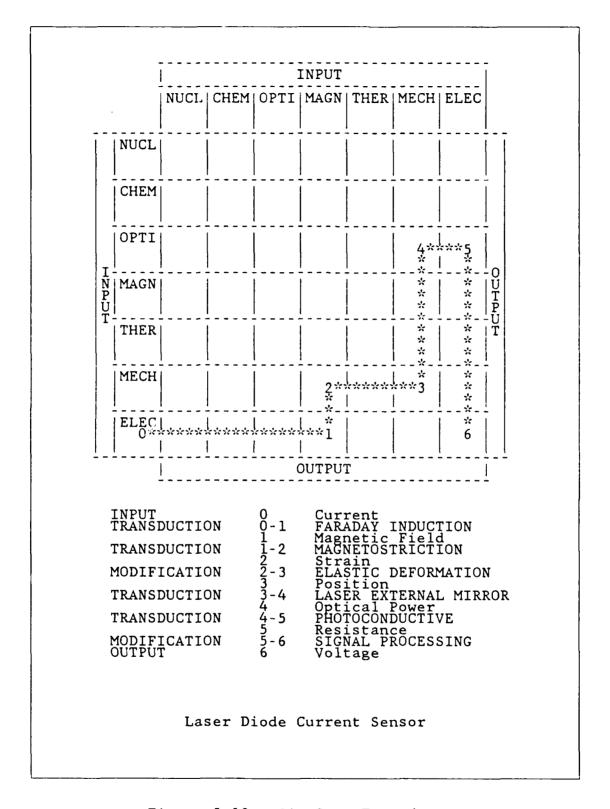


Figure 5.12 Six Step Transducer.

A laser diode configured with an external reflector will undergo large changes in output intensity as the external reflector is moved a very small distance. This movement of the external reflector changes the phase of the light which is reflected back into the laser cavity. When the phase of the reflected light is such that in-phase feedback occurs, the output intensity of the laser diode is increased. When the phase of the reflected light is such that out-of-phase feedback occurs, the output intensity of the laser diode is decreased. Since the wavelength of light is very short, a very small displacement of the external reflector may be detected in this manner. [Ref. 15]

The Laser Diode Current Sensor operates upon the principles οf magnetostriction. Faraday induction. photoconductance, elastic deformation, and the laser external mirror. Current passing through a conductor induces a magnetic field about that conductor Faraday induction. A coil of the conductor is wrapped around a length of magnetostrictive tubing upon the end of which is mounted a laser external mirror. The magnetic field caused by the current in the conductor induces a strain in the magnetostrictive material. The strain in the magnetostrictive material causes the laser external mirror mounted thereupon to change its relative position. position changes, the laser output intensity likewise changes due to the feedback of the laser external mirror. This optical output power is converted to resistance through the action of a photoconductive device.

The transduction path of this device is rather long and complicated. However, as in all cases, the final step must be an electrical modifier. In this case, the last step is not specified beyond the general term, signal processing. The signal processing may consist of a Bridge Circuit or some other suitable electrical modifier capable of converting a change in resistance to voltage.

7. Seven Step

A representative example of a transducer with a seven step transduction path is the Fiber Optic Spectrophone. It converts the input measurand, chemical composition, into an electrical output signal. The seven step transduction path of this device is illustrated in Figure 5.13.

The Fiber Optic Spectrophone operates in much the same manner as an optical fiber acoustic sensor utilizing interferometric techniques. An optical absorption contains the trace chemical compound to be detected. cell is irradiated by a laser beam of an appropriate This raises the temperature of the trace gas wavelength. through the process of photoabsorption. As the gas heats, the pressure within the cell increases due to thermal expansion. This pressure increase causes the cell expand, inducing a strain upon an optical fiber wrapped around the cell. The elasto-optic effect converts strain to a refractive index change which is in detected by a phase interferometer. interferometer has an optical power output which is allowed to fall upon a photoconductive device. The photoconductive device then converts the incident optical power to electrical resistance. [Ref. 15]

This transduction path represents a very complex device which utilizes a long sequence of transduction and modification principles. However, it is different only in degree from a simple one step device. The same methodology applies to all sensors and transduction paths, regardless of length. They all begin with an input measurand and terminate with an electrical modification step.

		<u> </u> 			INPUT				
,		NUCL	CHEM	OPTI	MAGN	THER	MECH	ELEC	
-	NUCL	<u> </u>	<u></u>	<u> </u>	<u> </u>	<u> </u>	<u> </u>	<u> </u>	<u>-</u>
	CHEM 0*	 ******	 	 ******	 ******	 ***1 *	 	 	
	OPTI	<u>-</u>	: · 	5**	<u>-</u> ******	* - · 	<u>-</u> ***4 *	<u>-</u>	<u>-</u>
I N P U	MAGN	<u>-</u>			<u>-</u> 	*- * * *	* * *	<u></u>	0 0 1 1
Т	THER			* * * * * * * * * * * * * * * * * * *		* - · 	* * * * * * * * * * * * * * * * * * *		T
	MECH			× * *		2**	* * ***3		
	ELEC			6**		 **** ** *		 ***7	
-		<u>.</u> 		<u>-</u>	OUTPU	r 	<u></u>		<u> </u>
1	INPUT TRANSI TRANSI MODIFI TRANSI	DUCTIO ICATIO	ON ON	0 - 1 1 - 2 2 - 3 3 - 4	PHOT Temp THE Pres ELAS	roabso perato RMAL ssure STIC ain	Compo ORPTIO 1re EXPANS DEFORM	ON SION MATIO	N
]	MODIF: TRANS	ICATI	ON	4-5 5-6	Ref: PHAS Opt: PHO	ractiv SE IN ical l	ve Ind TERFEI Power	dex ROMETI VE	
ļ	MODIF: OUTPU	ICATIO	N	6 - 7 7	SIGI Vol	NAL PI tage	ce ROCES	SING	
		F	iber (Optic	Spec	troph	one		

Figure 5.13 Seven Step Transducer.

E. A SAMPLE INVESTIGATION

In the previous section, the transduction path method was shown to be useful as a sensor description and analysis technique. Existing sensors of various transduction path lengths were presented and analyzed through use of the transduction path method. However, the method is also useful as a means of investigating sensor configurations. For any given class of sensor, the method is capable of systematically generating all possible sensor configurations utilizing the known transduction and modification principles. The actual techniques employed are similar to those presented in previous sections and are not presented here. Appendix P may be consulted for further details.

The sensor configurations thus generated may be broken down into two groups. The first group consists of those transduction paths which have actually been implemented as actual sensor designs. The second group consists of those transduction paths which have not been implemented as actual sensor designs. The latter group would require closer examination to determine whether or not they might be feasible as potential sensor configurations.

In this section, an investigation is made of all possible three step pressure sensor configurations. The techniques described in Appendix P are utilized to generate all possible transduction paths of the requisite length which lead from the input measurand, pressure, to an electrical output signal. The first and second step may consist of either transduction or modification principles, while the last step is an electrical modifier.

An examination of the tables contained in Chapter IV reveals that only two principles are listed which have pressure as an input measurand and also have a non-electrical output measurand. The two principles thus

identified are elastic deformation and triboluminescence. These principles convert the input measurand, pressure, into mechanical and optical forms of energy, respectively. These principles would be candidates for the first step of the transduction path. The second step would consist of either a transduction or a modification principle drawn from Tables XI and XII. Examination of these tables reveals that 18 transduction or modification principles exist which satisfy the necessary conditions. The third step would, of course, be an electrical modifier drawn from Table XII. In the subsequent investigation, this step will simply be identified as "Signal Processing".

Based upon the above observations, three step pressure sensors may be divided into two general categories. categories are based upon the energy form of the first intermediate measurand of the transduction path. Since the two candidates for the first step are elastic deformation and triboluminescence, the two categories are mechanical and In the following sections. optical. the sensor configurations within each category are discussed. Furthermore, each configuration is examined to determine if it represents an actual sensor design or a potential sensor design.

1. Mechanical Three Step Pressure Sensors

A generalized transduction path diagram has been prepared for each of the two categories identified above. Associated with each diagram is a listing of those combinations of principles which have been found to satisfy that particular transduction path. In the case of three step pressure sensors which utilize elastic deformation as their first step, the diagram would appear as illustrated in Figure 5.14. This generalized transduction path diagram is representative of the 13 possible sensor configurations identified in Tables XVIII and XIX.

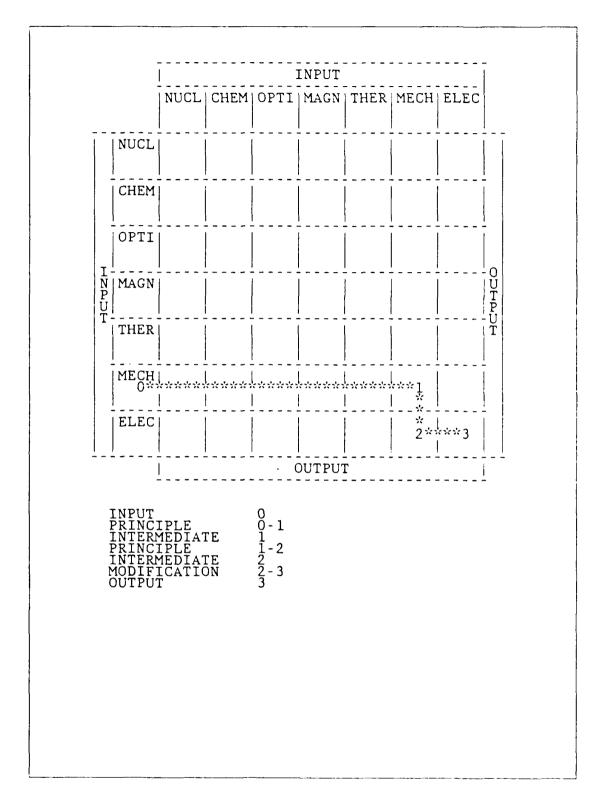


Figure 5.14 Mechanical Three Step Pressure Sensor.

TABLE XVIII
Mechanical Three Step Paths I

	Step	No.	Measurand/Principle
Path #1	INPUT MODIFICATION INTERMEDIATE TRANSDUCTION INTERMEDIATE MODIFICATION OUTPUT	0 0-1 1-2 2-3	Pressure ELASTIC DEFORMATION Deflection VARIABLE DIELECTRIC Capacitance SIGNAL PROCESSING Voltage
Path #2	INPUT MODIFICATION INTERMEDIATE TRANSDUCTION INTERMEDIATE MODIFICATION OUTPUT	0 0 - 1 1 - 2 2 - 3 3	Pressure ELASTIC DEFORMATION Displacement VARIABLE RELUCTANCE Inductance SIGNAL PROCESSING Voltage
Path #3	INPUT MODIFICATION INTERMEDIATE TRANSDUCTION	0 0 - 1 1 1 - 2	Pressure ELASTIC DEFORMATION Microbends NONE, PATH INCOMPLETE
Path #4	INPUT MODIFICATION INTERMEDIATE TRANSDUCTION INTERMEDIATE MODIFICATION OUTPUT	0 0-1 1-2 2-3	Pressure ELASTIC DEFORMATION Position CONDUCTIVE ELASTOMER Resistance SIGNAL PROCESSING Voltage
Path #5	INPUT MODIFICATION INTERMEDIATE TRANSDUCTION INTERMEDIATE MODIFICATION OUTPUT	0 0-1 1-2 2-3	Pressure ELASTIC DEFORMATION Position MECHANICAL SWITCH Resistance SIGNAL PROCESSING Voltage
Path #6	INPUT MODIFICATION INTERMEDIATE TRANSDUCTION INTERMEDIATE MODIFICATION OUTPUT	0 0-1 1-2 2-3	Pressure ELASTIC DEFORMATION Position POTENTIOMETRIC Resistance SIGNAL PROCESSING Voltage
Path #7	INPUT MODIFICATION INTERMEDIATE TRANSDUCTION INTERMEDIATE MODIFICATION OUTPUT	0 0 - 1 1 - 2 2 2 - 3	Pressure ELASTIC DEFORMATION Position VARIABLE RELUCTANCE Inductance SIGNAL PROCESSING Voltage

See Figure 5.14 for appropriate transduction path diagram.

The configurations listed in Tables XVIII and XIX have been labelled as paths 1 through 13. It is now necessary to examine each of the proposed sensor configurations to determine whether or not it represents an actual sensor design. If not, a closer look is taken to determine if it is a feasible, but untried, design.

Transduction path #1 represents configuration which has been implemented in actual sensor designs. This particular configuration is commonly referred to as a Capacitance Manometer and has been described in [Ref. 16]. Briefly, the device operates by subjecting a sensing diaphragm to the pressure which is to be measured. diaphragm is a common element in a double-sided capacitor plate arrangement. When the diaphragm deflects in response to the applied pressure, the geometry of the capacitor arrangement changes and a differential capacitance is generated. In general, a change in capacitance may be obtained in two ways. In this example, the spacing of the metallic elements is changed. This alters the thickness of the dielectric while keeping the dielectric constant fixed. A second way to generate a capacitance change is to alter the dielectric constant while keeping the plate spacing fixed as may be seen in path #10. As a final step, capacitance change is detected by electronic circuitry and a suitable output signal generated. [Ref. 17]

Path #2 is a transduction path configuration which has been implemented in present day sensor designs as an LVDT Pressure Transducer. The device operates by subjecting a sensing diaphragm to the pressure which is to be measured. The diaphragm is mechanically connected to the core element of a linear variable differential transformer (LVDT). When the diaphragm deflects in response to the applied pressure, the core of the LVDT is displaced. This changes the induction ratio of the differential transformer because the

TABLE XIX
Mechanical Three Step Paths II

•	Step	No.	Measurand/Principle
Path #8	INPUT MODIFICATION INTERMEDIATE TRANSDUCTION INTERMEDIATE MODIFICATION OUTPUT	0 0-1 1-2 2-3	Pressure ELASTIC DEFORMATION Proximity PROXIMITY EFFECT Resistance SIGNAL PROCESSING Voltage
Path #9	INPUT MODIFICATION INTERMEDIATE TRANSDUCTION INTERMEDIATE MODIFICATION OUTPUT	0 0-1 1-2 2-3	Pressure ELASTIC DEFORMATION Strain PIEZOELECTRIC Charge or Emf SIGNAL PROCESSING Voltage
Path #10	INPUT MODIFICATION INTERMEDIATE TRANSDUCTION INTERMEDIATE MODIFICATION OUTPUT	0 0-1 1-2 2-3	Pressure ELASTIC DEFORMATION Strain PIEZO-OPTICAL Dielectric Constant SIGNAL PROCESSING Voltage
Path #11	INPUT MODIFICATION INTERMEDIATE TRANSDUCTION INTERMEDIATE MODIFICATION OUTPUT	0 - 1 1 - 2 2 - 3	Pressure ELASTIC DEFORMATION Strain PIEZORESISTANCE Resistance SIGNAL PROCESSING Voltage
Path #12	INPUT MODIFICATION INTERMEDIATE TRANSDUCTION INTERMEDIATE MODIFICATION OUTPUT	0 0-1 1-2 2-3	Pressure ELASTIC DEFORMATION Strain PN PIEZOJUNCTION Current SIGNAL PROCESSING Voltage
Path #13	INPUT MODIFICATION INTERMEDIATE TRANSDUCTION INTERMEDIATE MODIFICATION OUTPUT	0 0-1 1-2 2-3	Pressure ELASTIC DEFORMATION Strain THERMOELASTIC EFFECT Emf SIGNAL PROCESSING Voltage

See Figure 5.14 for appropriate transduction path diagram.

Transducer which has been described in [Ref. 21]. The device is constructed in a manner similar to the Pressure Switch described above. An elastic diaphragm is exposed to the pressure to be measured. Attached to the diaphragm is a contact which is caused to move across a precision potentiometer as the pressure changes. The output of the potentiometer is read as a resistance, or a resistance ratio, and may be easily converted to an equivalent pressure reading.

Path #7 represents a sensor configuration known as a Variable Reluctance Pressure Transducer. It has been implemented in actual sensor designs and is described [Ref. 22]. The operation is virtually identical to the LVDT Pressure Transducer described above. The primary difference is in the mechanical design of the elastic diaphragm. this particular configuration, the diaphragm is constructed of a magnetically permeable material. It is situated between two symmetric transformer assemblies and completes a magnetic circuit with each E-core. As pressure is applied, the diaphragm deflects toward one transformer assembly and away from the other. This increases the gap in the magnetic flux path of one core and decreases it in the other. As the gaps become unequal, the induction ratio between the two transformer assemblies changes. This ratio is conveniently measured in an AC bridge circuit which provides an output voltage proportional to the applied pressure. [Ref. 22]

Path #8 represents a sensor configuration which, to the knowledge of the author, has not been implemented as an actual sensor design. Such a device, if implemented, would utilize the principle of elastic deformation to convert pressure to a relative position or displacement. An elastic diaphragm exposed to the pressure to be measured would undergo a displacement proportional to the applied pressure. When a wire is carrying an alternating current, the current

has a tendency to crowd toward one side of a conductor owing to the proximity another current-carrying conductor. increases the resistance and is known as the proximity [Ref. 11]. suitable effect Through a mechanical arrangement, the displacement of the diaphragm could be used to change the separation between two such conductors. desired, the device could even be configured differential device using three conductors. Similar to the Capacitance Manometer described above, the device would have a current carrying conductor on the elastic diaphragm. Conductors carrying electrical current would be located on either side of the diaphragm. As the diaphragm is displaced, the spacing between conductors would be altered and a differential resistance would be measured. Utilizing a suitable bridge circuit, the differential resistance could be converted into a useful electrical signal.

Transduction path #9 is representative of a general class of existing piezoelectric pressure transducers. A related device, the Integrated Silicon Microbeam PI-FET Accelerometer [Ref. 13], has already been described in this chapter. A pressure sensing device would differ from an accelerometer only in the first step of the transduction path. In a pressure sensor, the silicon microbeam would be replaced by an elastic diaphragm. This would change the manner in which force is converted to strain. The rest of the transduction path would, however, remain the same.

Path # 10 is a sensor configuration which has been implemented in actual sensor designs. The configuration is known as a Capacitance Manometer and is closely related to the device described by path #1. This particular device, however, relies upon a change in dielectric constant to cause a capacitance change. Otherwise, the device is virtually identical to path #1.

Path #11 describes the operation of an existing configuration known a Thin-Diaphragm sensor as Piezoresistive Pressure Sensor [Ref. 23]. The operation of the device is based upon the exposure of a thin, elastic diaphragm to the pressure which is to be measured. Diffused upon the diaphragm are several piezoresistors which along with the diaphragm as it flexes under pressure. resulting change in resistance is easily detected through use of a suitable electrical bridge circuit. An advantage of this type of device is that it operates at fairly low stress levels. However, the device sensitivity is quite dependent upon diaphragm thickness. [Ref. 24]

Path #12 is a sensor configuration which has been implemented in present day sensor designs. It has been described in [Ref. 25] and is commonly referred to as a Piezojunction Pressure Transducer. Pressure is converted to mechanical strain through use of an appropriate elastic structure such as a cantilever, diaphragm, or beam. Fabricated upon the structure is a PN piezojunction which changes its electrical characteristics as it undergoes strain. In particular, the electrical current through the piezojunction varies as a function of strain. This current is then amplified and converted to voltage through appropriate signal processing.

Transduction path #13 is the last of the mechanical pressure sensor configurations to be explored. This configuration, to the best knowledge of the author, has not been implemented as an actual sensor design. The thermoelastic effect is the production of an electrical potential between two points in a stressed metal which are maintained at a constant temperature difference [Ref. 11]. The actual voltage generated is a function of the stress intensity and the temperature difference. Such a device, if implemented, would utilize the principle of elastic

deformation to convert pressure to a mechanical strain in metal. This strain would then be converted to an electrical potential through use of the thermoelastic effect. Since maintenance of a constant temperature difference is necessary, some temperature control circuitry would be necessary.

2. Optical Three Step Pressure Sensors

A generalized transduction path diagram for optical three step pressure sensors is illustrated in Figure 5.15. This generalized transduction path diagram is representative of the six possible sensor configurations identified in Table XX. Each of these configurations utilizes triboluminescence as the first step of the transduction path.

The configurations listed in Table XX have been labelled as paths 14 through 19. To the knowledge of the author, these six configurations have not been implemented as actual sensor designs. It is now necessary to examine each of the proposed sensor configurations to determine if any may represent a feasible sensor design.

Triboluminescence is an effect which causes a material to emit a glow when scratched, struck, or broken. Only a few materials such as sugar, mica, uranium salts, and ice exhibit this effect. [Ref. 11]

The six transduction paths identified in Table XX all utilize triboluminescence as their first step and some photoelectric effect as their second step. In order to implement any of the six configurations, a suitable mechanical arrangement would be necessary to inflict the necessary damage to the triboluminescent material as a function of pressure. Since damage to the material is necessary in order to cause the effect, such a sensor would probably have to be expendable after one use. It would

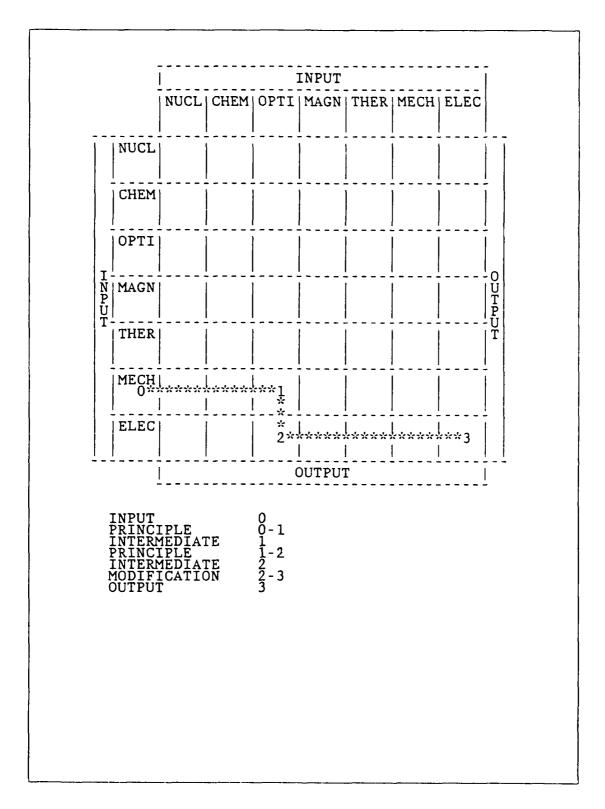


Figure 5.15 Optical Three Step Pressure Sensor.

TABLE XX
Optical Three Step Paths

	Step	No.	Measurand/Principle
Path #14	INPUT TRANSDUCTION INTERMEDIATE TRANSDUCTION INTERMEDIATE MODIFICATION OUTPUT	0 0-1 1-2 2-3	Pressure TRIBOLUMINESCENCE Optical Power APD Current SIGNAL PROCESSING Voltage
Path #15	INPUT TRANSDUCTION INTERMEDIATE TRANSDUCTION INTERMEDIATE MODIFICATION OUTPUT	0 0-1 1-2 2-3	Pressure TRIBOLUMINESCENCE Optical Power PHOTOCONDUCTIVE Resistance SIGNAL PROCESSING Voltage
Path #16	INPUT TRANSDUCTION INTERMEDIATE TRANSDUCTION INTERMEDIATE MODIFICATION OUTPUT	0 0-1 1-2 2-3	Pressure TRIBULUMINESCENCE Optical Power PHOTOEMISSIVE Charge Carrier SIGNAL PROCESSING Voltage
Path #17	INPUT TRANSDUCTION INTERMEDIATE TRANSDUCTION INTERMEDIATE MODIFICATION OUTPUT	0 0-1 1-2 2-3	Pressure TRIBOLUMINESCENCE Optical Power PHOTOVOLTAIC Emf SIGNAL PROCESSING Voltage
Path #18	INPUT TRANSDUCTION INTERMEDIATE TRANSDUCTION INTERMEDIATE MODIFICATION OUTPUT	0 0-1 1-2 2-3	Pressure TRIBOLUMINESCENCE Optical Power PHOTOVOLTAIC Electric Field SIGNAL PROCESSING Voltage
Path #19	INPUT TRANSDUCTION INTERMEDIATE TRANSDUCTION INTERMEDIATE MODIFICATION OUTPUT	0 0-1 1-2 2-3	Pressure TRIBOLUMINESCENCE Optical Power PIN PHOTOCURRENT Current SIGNAL PROCESSING Voltage

See Figure 5.15 for appropriate transduction path diagram.

likely find application in the detection of detonation pressure waves and other impulse-like phenomena.

The second step varies among the six configurations considered. Path #14 proposes using an avalanche photodiode (APD) as a means of detecting the light generated by the triboluminescent material. In a like manner, paths 15 through 19 utilize photoconductance, the photoemissive effect, the photovoltaic effect, and a PIN photodiode to convert light to electricity. The APD appears to be the most promising device for the second step due to gain since the light emission the triboluminescent material is likely to be small. photodiode would probably be the second choice, followed thereafter by the other photoelectric effects.

F. CONCLUSIONS

The transduction path method has been shown to be useful for sensor description and analysis. It is capable of describing the operation of any single or multistep transducer. The method is also useful for configuration investigation. Ιt is capable systematically generating all possible sensor configurations of a given class which utilize the known transduction and modification principles.

An investigation was carried out of all possible three step pressure sensor configurations. The investigation resulted in the generation of 19 possible transduction paths. One of these paths was incomplete. Ten of the paths represented sensor configurations which presently exist. However, eight paths were found which do not correspond to any of the sensor types examined in the course of this project.

To the best knowledge of the author, these eight configurations have never been implemented as actual sensor designs. While none of the new configurations appear to be promising as replacements for existing transducers, they may prove to be feasible within a narrow range of applications. However, further research and appropriate paper designs would be necessary.

VI. SUMMARY AND CONCLUSIONS

A. SUMMARY

The purpose of a solid state sensor is to convert an input measurand to an electrical output signal. The input measurand is manifested as a signal belonging to one of seven different forms of energy. These forms include mechanical, thermal, electrical, magnetic, optical, chemical, and nuclear energy. Complete listings of physical quantities associated with each form of energy have been attached as Appendices A through G.

When this signal is other than electrical in nature, must undergo the process of transduction before it can be processed by electronic devices. This process transduction may be described through what is now referred to as the "transduction path" method. The method defines a transduction path as a sequence of individual transduction or modification principles which lead from measurand to an electrical output signal. Transduction is the process by which one form of energy is converted into another form of energy and modification is the process by which one form of energy is changed to a like form energy.

The transduction path method represents a means of describing the operation of a solid state sensor. However, it requires knowledge of transduction and modification principles drawn from all fields of science. It is for this reason that the known transduction and modification principles have been tabulated alphabetically in Appendix H and by energy form in Appendices I through O.

One way to represent these transduction and modification principles is in matrix form. A symmetric 7 X 7 matrix with rows and columns corresponding to the seven forms of energy is sufficient to illustrate all possible transduction and modification elements. The number of principles belonging to each family, based on input-output energy forms, have been annotated in Figure 6.1. The number in each block represents the number of known principles drawn from all fields of science which make that particular energy transduction or modification possible.

In order to extensively test the transduction path method, information was collected on 108 different classes of sensors and transducers. This information was gathered from technical journals and specification sheets from approximately 160 manufacturers. The transduction path of each sensor was determined and examined for compatibility with the transduction path diagram. The sensors examined were found to range from simple one step to complex seven step transduction paths. All were found to be compatible with the transduction path method.

A representative example of a transducer with a seven step transduction path was shown to be the Fiber Optic Spectrophone. It converts the input measurand, chemical composition, into an electrical output signal. The seven step transduction path of this device is illustrated in Figure 6.2 and is a representative example of a completed transduction path diagram.

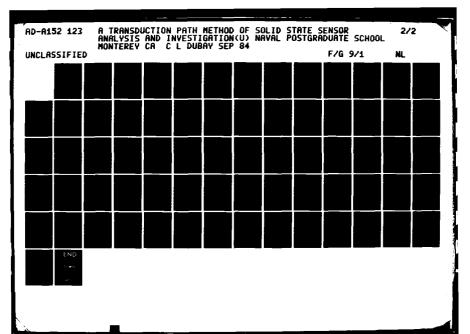
The transduction path method has been shown to be useful for sensor description and analysis. However, the method is also useful as a means of investigating sensor configurations. For any given class of sensor, the method is capable of systematically generating all possible sensor configurations utilizing the known transduction and modification principles.

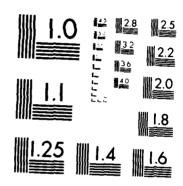
		NUCL	CHEM	OPTI	MAGN	THER	MECH	ELEC
,	NUCL	1		5	1	1		6
•	СНЕМ		2	7		4	6	11
I · N P U T	OPTI		2	11	1	1	1	10
	MAGN			4	2	1	4	8
	THER		2	9	1	3	1	13
	месн	1		24	6	4	19	20
	ELEC	1	1	7	1	5	11	28

Figure 6.1 Distribution of Principles.

An investigation was carried out of all possible three step pressure sensor configurations. The techniques described in Appendix P were utilized to generate all possible transduction paths of the requisite length.

The investigation resulted in the generation of 19 possible transduction paths. One of these was discovered to be incomplete and consequently not a valid path. Ten of the paths were found to represent sensor configurations which





MICROCOPY RESOLUTION TEST CHART
NATHEBURY ACTURE STANDARDS 1963 A

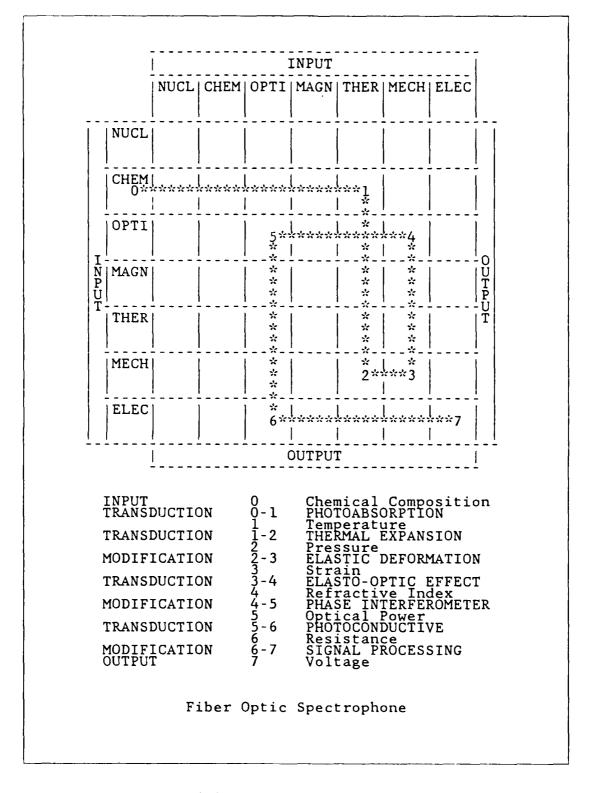


Figure 6.2 Seven Step Transducer.

currently exist and references have been cited. However, eight paths were found which do not correspond to any of the sensor types examined in the course of this project.

To the best knowledge of the author, these eight configurations have never been implemented as actual sensor designs. It is quite possible that some of the new configurations may prove to be feasible within a narrow range of applications. However, further research and appropriate paper designs would be necessary.

B. CONCLUSIONS

The transduction path method has been shown to be useful as a method of sensor analysis. Given a sensor of any type, it should be possible to generate a suitable transduction path diagram which would accurately describe the operation of that sensor. Furthermore, the method may be used to generate transduction paths and thus makes possible a systematic investigation of sensor configurations.

While the example investigation carried out in Chapter V did not reveal any new sensor configurations which were particularly promising, it did manage to generate 18 transduction paths. Ten of these paths were known sensor configurations while the other eight were not. This does, however, reinforce the idea that the transduction path method may be used to systematically survey a given class of sensors to determine if some principle is being under-utilized.

The investigation carried out is as good or as bad, of course, as the lists of principles which have been drawn up in support of the method. The listings of principles contained within this paper are as complete as the author has been able to manage. Some principles may have been overlooked and the reader may recognize gaps that need to be

filled. New principles may be easily added at any time by simply making the proper entries in Chapter IV and the appendices. The study of solid state sensors is practically limitless in scope and it is hoped that this paper may prove useful as a starting point for further research in this area.

APPENDIX A

MECHANICAL PHYSICAL QUANTITIES

ACCELERATION* acceleration, angular acceleration, linear ACOUSTIC ENERGY* acoustic emission acoustic power aeroelasticity altitude ANGLE* ANGLE"
area
ATTRACTION, MAGNETIC*
brittleness
CONTRACTION, LATERAL*
DEFLECTION*
DEFORMATION*
DENSITY*
depth liquid DENSITY*

depth, liquid
detonation
DIAMETER, CONDUCTOR*
DIAMETER, WIRE*
DIMENSION*
DIPOLE ALIGNMENT*
direction
DIRECTION OF MOTION*
DISPLACEMENT*
displacement, angular
displacement, linear
distance distance elasticity ELASTIC PROPERTIES* energy, internal energy, kinetic energy, potential fatigue FLOW FLOW, FLUID* flow, gas FLOW RATE, MASS* flow rate, volumetric FORCE* FORCE*
fracture
fracture
frequency, ACOUSTIC*
frequency, MECHANICAL*
frequency, FLEXURAL*
frequency, TORSIONAL*
friction*
friction, Liquid*
friction, Solid*
HARDNESS*
hydroelasticity
IMMERSION, PARTICLE*
INCLINATION*
LENGTH*
level level LEVEL, LIQUID* load mass

* indicates measurand associated with principles listed in Chapter IV.

```
MICROBENDS*
MOMENTUM, ANGULAR* momentum, linear
motion
MOVEMENT, AIR*
MOVEMENT, POLAR FLUID*
PATH LENGTH DIFFERENCE*
permeability
plasticity
POSITION*
POSITION, ANGULAR*
position, linear
PRESSURE*
pressure, absolute
pressure, barometric
pressure, blood
pressure, differential
pressure, gage
pressure, impact
pressure, partial
PRESSURE, SOUND*
PRESSURE, SOUND*
pressure, stagnation
pressure, static
PRESTRAIN*
PROXIMITY*
PROXIMITY, CONDUCTOR*
ROTATION*
SAW*
SEPARATED CASES*
SEPARATED GASES*
SHAPE*
SHOCK*
 SOUND*
sound attenuation sound diffraction
sound dispersion
sound dispersion
sound energy flux
sound intensity
sound reflectivity
sound refractive index
sound scattering
specific gravity
specific gravity
speed
STRAIN*
STRAIN, LOCALIZED*
STRESS*
STRESS, LONGITUDINAL*
TENSION*
TENSION, SURFACE*
THICKNESS*
TORQUE*
ULTRASONIC*
Vacuum
VELOCITY*
VELOCITY, ANGULAR*
VELOCITY, AIR*
VELOCITY, FLOW*
velocity, linear
VELOCITY, SAW*
Velocity. sound
velocity, sound
VIBRATION*
viscoelasticity
viscoplasticity
 viscosity
VOLUME*
WAVELENGTH*
weight
work
```

APPENDIX B THERMAL PHYSICAL QUANTITIES

CONDUCTIVITY, THERMAL*
diffusivity, thermal
HEAT*
heat capacity
heat flow
HEAT FLUX*
HEAT TRANSFER RATE*
infrared radiation
POINT, BOILING*
point, dew
POINT, FREEZING*
point, ice
point, ice
point, sublimation
point, triple
specific heat
TEMPERATURE*
TEMPERATURE CHANGE*
TEMPERATURE, COOLING*
TEMPERATURE, DIFFERENCE*
TEMPERATURE, GRADIENT*
TEMPERATURE, NOISE*

* indicates measurand associated with principles listed in Chapter IV.

APPENDIX C ELECTRICAL PHYSICAL QUANTITIES

admittance
CAPACITANCE*
CHARGE*
CHARGE CARRIER*
charge density
CHARGE LOSS*
CONDUCTIVITY*
CORONA DISCHARGE*
CURRENT*
CURRENT, RESTORING*
CURRENT, VACUUM*
DIELECTRIC CONSTANT*
ELECTRIC FIELD*
ELECTRIC FIELD*
ELECTRIC FIELD AC*
electric flux
electric flux
electric flux
electric flux
EMF, AC*
emf, analog
EMF, GATE*
frequency
FREQUENCY, DIFFERENCE*
FREQUENCY, ELECTRIC*
FREQUENCY, ELECTRIC*
FREQUENCY, ELECTRIC*
FREQUENCY, ELECTRIC*
FREQUENCY, ELECTROMAGNETIC*
FREQUENCY, ELECTROMAGNETIC*
TARGOUENCY
IMPEDANCE*
INDUCTANCE*
INDUCTANCE*
INDUCTANCE*
INDUCTANCE*
INDUCTANCE*
FRESISTANCE
RESISTANCE
RE

* indicates measurand associated with principles listed in Chapter IV.

APPENDIX D MAGNETIC PHYSICAL QUANTITIES

FLUX, CHANGE*
FLUX, DENSITY*
FREQUENCY, ELECTROMAGNETIC*
MAGNETIC FIELD, DYNAMIC*
MAGNETIC FIELD, INTENSITY*
MAGNETIC FIELD, STATIC*
MAGNETIC FIELD, STATIC*
MAGNETIC INDUCTION*
MAGNETIZATION*
MAGNETIZATION DIRECTION*
MAGNETIZATION, SUDDEN*
magnetic flux
magnetic flux
magnetic flux density
magnetic flux density
magnetic flux
permittivity
RADIATION, ELECTROMAGNETIC*
reluctance
WAVE, ELECTROMAGNETIC*

* indicates measurand associated with principles listed in Chapter IV.

APPENDIX E OPTICAL PHYSICAL QUANTITIES

ABSORPTANCE*
birefringence
COLOR, ANY*
COLOR, PRIMARY*
COUPLING COEFFICIENT*
flourescence
FREQUENCY, OPTICAL*
ILLUMINATION*
ILLUMINATION, DIFFERENCE*
IMAGE, DECEPTIVE*
IMAGE, OPTICAL*
INFRARED RADIATION*
intensity
LIGHT*
LIGHT EMISSION*
light, laser
luminance
luminous flux
luminous intensity
MAX ENERGY WAVELENGTH*
MAX POLARIZED LIGHT*
OPAQUENESS*
OPTICAL COUPLING*
OPTICAL COUPLING*
OPTICAL POWER*
PHASE DIFFERENCE*
POLARIZING ANGLE*
RADIANT HEAT*
REFLECTIVITY*
REFLECTIVITY*
REFLECTIVITY*
REFRACTIVE INDEX*
scattering
scintillation
SPECTRAL LINE SEPARATION*
TRANSMISSIVITY*
turbidity
ULTRAVIOLET LIGHT*
VISIBLE, LIGHT*
VISION, binary
vision, color
vision, gray scale
wavelength

* indicates measurand associated with principles listed in Chapter IV.

APPENDIX F CHEMICAL PHYSICAL QUANTITIES

acidity
alkalinity
alkalinity
atomic weight
BIOLOGICAL MECHANISM*
CHEMICAL COMPOSITION*
CHEMICAL REACTION RATE*
CHEMICAL REACTION RATE*
chemical substance
CHEMICAL STATE*
CHEMICAL CONCENTRATION*
concentration, combustibles
concentration, dissolved oxygen
CONCENTRATION, GAS*
CONCENTRATION, IONIC*
CONCENTRATION, NO*
CONCENTRATION, OXYGEN*
CONCENTRATION, SALT*
CONCENTRATION, YAPOR*
CRYSTALLIZATION*
DIFFUSION RATE*
diffusivity
GAS, SAMPLE*
HUMIDITY*
humidity, absolute
humidity, relative
humidity, relative
humidity, specific
moisture
molecular weight
OXIDATION*
solubility
SOLUBILITY, GAS*

* indicates measurand associated with principle listed in Chapter IV.

APPENDIX G

NUCLEAR PHYSICAL QUANTITIES

BOMBARDMENT, NUCLEAR
dose absorbed
FREQUENCY, ELECTROMAGNETIC*
neutron flux density
radiation, alpha
radiation, beta
radiation, cerenkov
radiation, cosmic
RADIATION, GAMMA RAY*
RADIATION, IONIZING*
RADIATION, NUCLEAR*
RADIATION, X-RAY*
radioactivity

 indicates measurand associated with principles listed in Chapter IV.

APPENDIX H

ALPHABETICAL LISTING OF PRINCIPLES

```
ABSORPTION (Unless otherwise indicated, see Reference 11) chemical composition to optical power thickness to optical power
ACOUSTIC INTERFERENCE
     frequency, acoustic
                                   to
                                         acoustic energy
ACOUSTIC PROPAGATION (See Reference 26)
     elastic properties
                                         saw velocity
                                   to
ACOUSTOELECTRIC (See Reference 27)
     pressure, sound
                                   to
                                         emf
ADSORPTION
     chemical concentration
                                   to
                                         chemical concentration
AMPERE'S LAW
     current
                                   tο
                                         force
AMPLITUDE MODULATION (See Reference 15)
     absorptance
                                         optical power
                                   to
     polarization
coupling coefficient
transmissivity
optical coupling
                                   to
                                         optical power
                                         optical power optical power optical power
                                   to
                                   to
                                   to
APD (See Reference 28)
     optical power
                                   to
                                         current
ARCHIMEDE'S PRINCIPLE
     density
                                   to
                                         force
ARRHENIUS EQUATION
                                         chemical reaction rate
     temperature
                                   to
ATMOLYSIS
     chemical composition
                                         separated gases
                                   to
BARKHAUSEN EFFECT magnetic field
                                         flux density
                                   to
BARNETT EFFECT
     rotation
                                         magnetization
                                   to
BAUSCHINGER EFFECT
     prestrain
                                   to
                                         elastic properties
BECQUEREL EFFECT illumination difference
                                   to
                                         emf
BENEDICK EFFECT
     emf
                                         temperature difference
                                   to
BIOLUMINESCENCE (See Reference 29)
                                         light emission
     biological mechanism
BLACKBODY RADIATION (See Reference 30)
     temperature
                                   to
                                         radiant heat
```

```
BREMSTRAHLUNG RADIATION
    electrons
                                to
                                      x-ray radiation
BREWSTER'S LAW
                                      max polarized light
    polarizing angle
                                to
BRIDGE CIRCUIT (See Reference 4)
    resistance
                                to
                                      restoring current
    resistance
                                 to
                                      emf
CAPACITIVE PI-FET (See Reference 13)
                                      emf
    charge
CAPILLARY COLUMN (See Reference 31)
    gas sample
                                      separated gases
                                to
CATHODIC REDUCTION (See Reference 32)
    oxygen concentràtion
                                      current
CAVITATION
    angular velocity
                                to
                                      sound
CCD (See Reference 28)
    òptical image
CERENKOV EFFECT
    electrons
                                      light emission light emission
                                to
    gamma ray radiation
                                to
CFT (See Reference 33)
    gate resistance
                                      current
CHARGE AMPLIFIER (See Reference 34)
                                      émf
    charge
                                 to
    charge
                                 to
                                      current
CHARGE MOBILITY (See Reference 25) charge carrier to
                                      resistance
CHEMISORPTION (See Reference 35)
gas concentration to
NO concentration to
                                      capacitance
                                      resistance
    vapor concentration
                                      elastic properties
                                to
CHRISTIANSEN EFFECT
    refractive index
                                to
                                      optical power
COLOR MIXING
    primary colors
                                      any color
COMBUSTION (See Reference 29) oxidation
                                 to
                                      light emission
    oxidation
CONDUCTIVE ELASTOMER (See Reference 19)
    position
                                      resistance
                                 to
    shape
                                      resistance
                                 to
    force
                                 to
                                      resistance
CORBINO EFFECT
    magnetic field
                                 to
                                      current
COULOMB'S LAW
                                      optical coupling
    proximity
                                 to
CRAFT'S RULE
    pressure
                                to
                                      boiling point
```

```
CRYSTALLUMINESCENCE
    crystallization
                                      light emission
                                to
CURIE-WEISS LAW
    temperature
                                to
                                      permeability
DIFFERENTIAL TRANSFORMER (See Reference 22)
    inductance
                                      emf
DIFFRACTION
    wire diameter
                                to
                                      optical power
DONNAN MEMBRANE EQUILIBRIUM
                                      diffusion rate
    chemical concentration
                                to
DOPPLER (ACOUSTIC)
    velocity
                                      frequency, acoustic
                                to
DOPPLER (ELECTRIC)
    velocity
                                      frequency, electromagnetic
                                to
DOPPLER (MAGNETIC)
    velocity
                                to
                                      frequency, electromagnetic
DOPPLER (OPTICAL)
    veločity
                                to
                                      frequency, optical
DOPPLER (NUCLEAR)
    velocity
                                to
                                      frequency, electromagnetic
DORN EFFECT (ELECTROKINETIC)
    particle immersion
                                to
                                      emf
ECKO (See Reference 36)
    impedance
                                      emf
                                to
ECOLD (See Reference 36)
    impedance
                                40
                                      emf
EDISON EFFECT
                                      vacuum current
    temperature
                                to
EINSTEIN-DE HASS EFFECT
    sudden magnetization
                                      angular momentum
ELASTIC DEFORMATION (See Reference 37) acceleration to deflection
    acceleration
    acceleration
                                to
                                      strain
    acceleration acoustic wave
                                to
                                      stress
                                to
                                      strain
    displacement
                                to
                                      position
    displacement
                                      strain
displacement
                                to
    force
                                to
    force
                                      position
                                to
                                      strain
deflection
    force
                                to
    pressure
                                to
                                      displacement
    pressure
                                to
    pressure
                                to
                                      microbends
    pressure
                                to
                                      position
                                      proximity strain
    pressure
                                to
    pressure
                                to
    pressure
                                to
                                      tension
    pressure, sound pressure, sound
                                      displacement
                                to
                                      position
                                to
    pressure, sound
                                to
                                      strain
    saw
                                to
                                      strain
    shock
                                to
                                      strain
    stress
                                to
                                      tension
```

```
ELASTIC DEFORMATION (continued)
    strain
                                 tó
                                      acoustic wave
                                      displacement
    strain
                                 to
                                      position
    strain
                                 to
                                      pressure, sound
    strain
                                 to
    strain
                                 to
                                      saw
                                to
                                      tension
    strain
    stress
                                 to
                                      strain
    tension
                                to
                                      strain
                                to
    torque
                                      strain
    vibration
                                to
                                      strain
ELASTIC LIMIT hardness
                                to
                                      deformation
ELASTO-OPTIC EFFECT (See Reference 15)
                                      refractive index
    strain
                                 to
ELECTRIC WIND EFFECT
    corona discharge
                                      air movement
                                to
ELECTROACOUSTIC (See Reference 27)
                                      pressure, sound
ELECTROCAPILLARITY
    emf
                                 to
                                      surface tension
ELECTROCHEMICAL (See Reference 29)
    chemical composition
                                to
                                      charge
ELECTROLUMINESCENCE
    ac electric field
                                 to
                                      light emission
ELECTROLYTIC DISSOCIATION chemical concentration
                                 to
                                      freezing point
ELECTRO-OPTICAL EFFECT
                                      dielectric constant refractive index
    emf
                                 to
    emf
                                 to
ELECTRO-OSMOSIS
                                      polar fluid movement
    emf
                                 to
ELECTROPLATING (See Reference 29)
                                      chemical reaction chemical reaction
    charge
    emf
                                 to
ELECTROSTRICTIVE
    emf
                                 to
                                      stress
    emf
                                 to
                                      strain
    electric field
                                 to
                                      strain
ENERGY BANDGAP SHIFT (See Reference 38)
    temperature
                                to
                                      absorptance
EOTVOS EFFECT
    direction of motion
                                 to
                                      force
ETTINGSHAUSEN EFFECT
    current
                                      temperature difference
                                 t o
EVANESCENCE (See Reference 15) position to
                                      coupling coefficient
FARADAY INDUCTION
    flux change
                                      emf
                                 to
    current
                                      magnetic field
                                 to
```

FARADAY ROTATION magnetic field	to	polarization
FERROELECTRIC electric field	to	dipole alignment
FISSION nuclear bombardment	to	radiation, electromagnetic
nuclear bombardment nuclear bombardment nuclear bombardment	to to to	heat optical power
FLUX DENSITY (See Reference 3	39)	ionizing radiation
position FOURIER'S LAW	to	magnetic field
temperature	to	heat flux
FTIR (See Reference 15) position	to	coupling coefficient
GALVANOMAGNETIC (HALL) static magnetic field static magnetic field		dc emf ac emf ac emf
dynamic magnetic field	to	
GATE CONTROLLED DIODE (See Reionic concentration dielectric constant	to	
GAUSS EFFECT magnetic field	to	resistance
GEIGER EFFECT nuclear radiation	to	light emission
GLADSTONE & DALE'S LAW temperature stress	to to	refractive index refractive index
GRAVITY PENDULUM (See Referenting inclination) position
HALLWOCK'S EFFECT ultraviolet light	to	charge loss
HENRY'S LAW temperature	to	gas solubility
HERTZ EFFECT ultraviolet light	to	electrical spark
HOT WIRE (See Reference 42) air velocity	to	temperature
HYDRODYNAMIC ELEMENT (See Ref	erend to	-
HYGROSCOPIC SALT (See Referer humidity	ice 44 to	
IMPEDANCE electrical frequency	to	current
INCANDESCENCE heat	to	light emission
INDUCTION current	to	emf

```
INDUCTIVE EDDY CURRENT (See Reference 3)
     proximity
                                        magnetic field
                                   to
INTERDIGITAL TRANSDUCER (See Reference 27)
                                         emf
                                   to
                                         saw
INTERFERENCE COATING
                                         reflection coefficient reflection coefficient
     thickness
                                   to
     wavelength
                                   to
ION MOVEMENT (See Reference 45) flow to
                                         current
ISFET (See Reference 46)
     chàrge
                                   to
                                         current
     chemical composition
                                   to
                                         current
JOHNSEN-RAHBEK EFFECT
                                         friction (solid)
     emf
                                   to
JONES EFFECT
     salt concentration
                                   to
                                         surface tension
JOSEPHSON JUNCTION (See Reference 47)
    infrared radiation magnetic field
                                   to
                                         current
                                   to
                                         current
     noise temperature
                                   to
                                         current
                                         current
     emf
                                   to
     resonant frequency
                                   to
                                         current
JOSHI EFFECT
     ionizing radiation
                                         current
                                   to
JOULE'S LAW
     current
                                   to
                                         temperature
KERR EFFECT
    electric field
electric field
                                         polarization
                                   to
                                         optical power
                                   to
KERR MAGNETO-OPTIC EFFECT flux density
                                   to
                                         polarization
KOHLRAUSCH'S LAW chemical concentration
                                   to
                                         conductivity
LAMBERT'S COSINE LAW angle
                                         illumination
                                   to
LAMBERT'S LAW thickness chemical concentration
                                        optical power optical power
                                   to
                                   to
LASER EXTERNAL MIRROR (See Reference 15)
     position
                                         optical power
                                   to
LED ELECTRO-OPTIC (See Reference 28)
                                         optical power
     current
LENS SYSTEM (See Reference 30) optical image t
                                         optical image
LIQUID CRYSTAL
    temperature magnetic field
                                         opaqueness
                                   to
                                         opaqueness
LORENTZ CONTRACTION
     velocity
                                   to
                                         length
```

LUMINESCENCE optical power nuclear radiation electromagnetic wave	to to to	light emission light emission light emission
MAGNETIC ANISOTROPY magnetization direction	to	force
MAGNETIC SOUND DISPERSION magnetic field	to	acoustic frequency
MAGNETORESISTANCE (See Reference magnetic field	ence to	39) impedance
MAGNETOSTRICTION strain magnetic field	to to	magnetic field strain
MATTHEISSEN'S RULE temperature	to	resistivity
MECHANICAL RESONANCE (See Ref	feren	ce 42) acoustic frequency
MECHANICAL SWITCH (See Reference position	ence . to	20) resistance
MIRAGE EFFECT heat	to	deceptive image
MOS CAPACITOR (See Reference capacitance	35) to	emf
NERNST EFFECT temperature gradient	to	ac emf
NTIR (See Reference 15) refractive index	to	optical power
NUMERICAL APERTURE (See Refer displacement	rence to	15) coupling coefficient
OHM'S LAW emf resistance	to to	current current
OPTICAL INTERFERENCE path length difference	to	optical power
OPTICAL ROTATION chemical concentration chemical composition	to to	polarization polarization
OSCILLATOR resonant frequency current impedance	to to to	emf frequency, electric frequency, electric
OSMOSIS chemical composition	to	pressure
PARAMAGNETISM oxygen concentration	to	magnetic attraction
PELTIER EFFECT current	to	temperature cooling

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PHASE INTERFEROMETER (See Reference 15)
phase difference to option
                                             optical power optical power
     refractive index
PHASE SHIFT OSCILLATOR (See Reference 48) resistance to emf (fm)
PHOTOABSORPTION (See Reference 15)
     chemical composition
                                              temperature
                                       to
     optical power radiant heat
                                       to
                                              temperature
                                       to
                                              temperature
PHOTOCONDUCTIVE
     ionizing radiation optical power
                                       to
                                              resistance
                                       to
                                              resistance
PHOTOELASTIC EFFECT
     stress
                                       to
                                              polarization
     strain
                                       to
                                              reflectivity
PHOTOEMISSIVE
     ionizing radiation optical power
                                              electrons
                                       to
                                       to
                                              charge carrier
PHOTOCHEMICAL (PHOTOGRAPHIC) (See Reference 29) optical image to chemical reac
                                              chemical reaction
PHOTOLUMINESCENCE visible light
                                              light emission
                                       to
PHOTOMAGNETIC EFFECT
     optical power
                                       to
                                              paramagnetism
PHOTOSYNTHESIS
     light
                                       to
                                              chemical reaction
PHOTOVOLTAIC
     ionizing radiation optical power optical power
                                       to
                                              emf
                                              emf
                                       to
                                       to
                                              electric field
PIEZOCALORIC (See Reference 26)
                                              heat
     stress
                                       tó
PIEZOELECTRIC
     stress
                                              emf
                                       to
     štress
                                       to
                                              charge
     strain
                                       to
                                              emf
                                             charge
ac emf
emf
     strain
                                       to
     frequency, resonant flexural frequency torsional frequency
                                       to
                                       to
                                       to
                                              emf
PIEZO-OPTICAL EFFECT
     stress
                                              dielectric constant refractive index
                                       to
     stress
PIEZORESISTANCE (See Reference 2)
     strain
                                              resistance
PIN (See Reference 28)
     charge carrier
                                       to
                                              current
PIN PHOTOCURRENT (See Reference 49) ionizing radiation to coptical power to c
                                              current
                                              current
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PINCH EFFECT
                                        conductor diameter
     current
                                  to
PLL (See Reference 50) frequency difference
                                        emf
PN PIEZOJUNCTION (See Reference 25)
     strain
                                        ćurrent
POISSON'S RATIO
     longitudinal stress
                                  to
                                        lateral contraction
POLYMER PAPA (See Reference 33)
    humidity
                                        gate resistance
POTENTIOMETRIC (See Reference 21)
                                  to
                                        resistance
     dimension
    position
                                        resistance
                                  to
POWER LAW (See Reference 51)
    power
                                  to
                                        current
     current
                                        power
                                  to
    voltage
resistance
                                  to
                                        power
                                  to
                                        power
PROXIMITY EFFECT
     conductor proximity
                                  to
                                        resistance
PTAT (See Reference 52)
     tèmperature
                                  to
                                        emf
PYROELECTRIC
     temperature change
                                  to
                                        emf
QUANTUM INTERFEROMETER (See Reference 47)
QUARTZ RESONATOR (See Reference 34)
     strain
                                        resonant frequency
RADIATION DARKENING (See Reference 15) ionizing radiation to abso
                                        absorptance
RADIATION PRESSURE
     light
                                        force
                                  to
RADIATIVE LOSSES (See Reference 53)
    microbends
                                        ábsorptance
                                  t o
RESISTANCE-PRESSURE EFFECT
    pressure
                                        resistance
                                  to
RESONANCE (See Reference 54) liquid level
                                        flexural frequency
torsional frequency
frequency, acoustic
    density acoustic wave
                                  to
                                  to
RIGHI-LEDUC EFFECT
    heat transfer rate
                                  to
                                        temperature difference
ROTOR (See Reference 55) velocity, angular
                                  to
                                        position
SAGNAC PHASE SHIFT (See Reference 15)
                                        pháse difference
     rotation
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SCHLIEREN GRATING (See Reference 15)
     displacement
                                          transmissivity
SENSING COIL (See Reference 56)
     inductance
flux change
                                          emf
                                          emf
SIGNAL PROCESSING
     electrical measurand
                                          electrical measurand
SNELL'S_LAW
     reflectivity
                                    to
                                          optical power
SONOLUMINESCENCE
                                          light emission light emission
     acoustic energy
                                    to
     ultrasonic
                                    to
SPARK GAP (PASCHEN'S LAW)
     emf
emf
                                    to
                                          heat
                                          ionization
                                    to
STARK EFFECT
     electric field
                                   to
                                          spectral line separation
STEFAN-BOLTZMANN LAW
     temperature
                                          radiant heat
TCD (See Reference 31) thermal conductivity
THERMAL CONDUCTIVITY (See Reference 31)
air velocity to tempe
mass flow rate to tempe
flow velocity to tempe
heat transfer rate to tempe
                                          température
                                          temperature
                                          temperature
                                          temperature
     separated gases chemical composition
                                    to
                                          temperature
                                   to
                                          temperature
THERMAL EXPANSION
     temperature
                                    to
                                          volume
     temperature
                                         pressure
THERMOCONDUCTANCE
     temperature
                                   to
                                          conductivity
THERMOELASTIC EFFECT
     stress
                                    to
                                          emf
THERMOELECTRIC (SEEBECK) temperature
                                    to
                                          emf
     temperature
                                    to
                                          current
THERMOMAGNETIC magnetic field intensity to
                                          thermoresistance
THERMO-OPTIC
     temperature
                                    to
                                          refractive index
THERMORESISTANCE (See Reference 12)
     temperature
                                          resistance
THERMOVOLTAIC JUNCTION
     temperature
                                          emf
TRIBOELECTRICITY
     chemical composition
                                          emf
                                    to
```

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TRIBOLUMINESCENCE
                                        light emission light emission
    friction
                                  to
    pressure
                                  to
UNIJUNCTION OSCILLATOR (See Reference 25)
                                        frequency, electric
    current
                                  to
VARIABLE BIREFRINGENCE (See Reference 57) strain to polarization
VARIABLE CONDUCTIVITY (See Reference 58)
     liquid level
                                        resistance
                                  to
VARIABLE DENSITY (See Reference 59) chemical concentration to r
                                        refractive index
VARIABLE DIELECTRIC
     liquid level
                                  to
                                        capacitance
    deflection
                                  to
                                        capacitance
     chemical state
                                  to
                                        gate resistance
                                        capacitance
     temperature
                                  to
VARIABLE OPACITY (See Reference 60)
    position
                                        óptical power
VARIABLE PERMEABILITY (See Reference 61)
    magnetic field
                                  to
                                       resonant frequency
VARIABLE REFLECTIVITY (See Reference 59) refractive index to optical power
VARIABLE REFRACTIVE INDEX (See Reference 59) liquid level to reflectivi
                                        reflectivity
VARIABLE RELUCTANCE (See Reference 14)
    position
displacement
                                        magnetic field
                                  to
                                  to
                                        inductance
    velocity
                                  to
                                        inductance
    position
                                        inductance
                                  to
    position, angular
                                  to
                                        inductance
VARISTOR (See Reference 62)
                                        resistance
VIBRATING WIRE (See Reference 63)
     tension
                                        frequency, mechanical
VILLARI EFFECT
    stress
                                        magnetic induction
VORTEX SHEDDING (See Reference 64) air velocity to
                                        density
WERTHEIM EFFECT
                                        emf
    torque
WIEGAND EFFECT (See Reference 14)
magnetic field to
                                        flux change
WIEN EFFECT
    emf
                                        conductivity
                                  to
WIEN'S DISPLACEMENT LAW
    temperature
                                        max energy wavelength
WINSLOW EFFECT
    emf
                                        friction (liquid)
                                  to
```

WORKMAN-REYNOLDS EFFECT freezing point

to emf

ZENER EFFECT voltage

to current

ZIRCONIUM OXIDE CELL (See Reference 65) oxygen concentration to emf

*Unless otherwise indicated, see Reference ll for all entries.

APPENDIX I

NUCLEAR OUTPUT PRINCIPLES

<u>*************************************</u>				
NUCLEAR		>	NUCLEAR	
FISSION nuclear be nuclear be nuclear be nuclear be	ombardment ombardment	to to to	radiation, heat optical pow ionizing ra	electromagnetic er diation
*****	chining and a single special single s	estestestestes	ic also also also also also also also also	********
CHEMICAL		>	NUCLEAR	
ite		estestestestes	e sie sie sie sie sie sie sie sie sie si	************
OPTICAL		>	NUCLEAR	
	ĸĸĸĸĸĸĸĸĸĸĸĸĸĸĸĸĸĸ	estestestestest	<mark>cht hicht sie</mark> cht sie de hicht hicht	*****
MAGNETIC		>	NUCLEAR	
********	**********	ch hich hich	chink which which which	*****
THERMAL		>	NUCLEAR	
ik i	t de	estestestestest	**********	*****
MECHANICAL		>	NUCLEAR	
DOPPLER (NUCLE velocity	CAR)	to	frequency,	electromagnetic

ELECTRICAL		>	NUCLEAR	
BREMSTRAHLUNG electrons	RADIATION	to	x-ray radia	tion
*******	*****	*****	********	****

APPENDIX J CHEMICAL OUTPUT PRINCIPLES

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NUCLEAR	>	CHEMICAL
	le sie sie sie sie s	de sile sile sile sile sile sile sile sil
CHEMICAL	>	CHEMICAL
ADSORPTION chemical concentration	to	chemical concentration
DONNAN MEMBRANE EQUILIBRIUM chemical concentration	to	diffusion rate
ste de	lestestestestes	de sde sde sde sde sde sde sde sde sde s
OPTICAL	>	CHEMICAL
PHOTOCHEMICAL (PHOTOGRAPHIC) optical image	to	chemical reaction
PHOTOSYNTHESIS light	to	chemical reaction
ste	le ske ske ske ske	de sie sie sie sie sie sie sie si. Die sie sie sie sie sie sie sie sie sie s
MAGNETIC	-•>	CHEMICAL
MAGNETIC		
	k strik ik str	
ंदे को	k strik ik str	
**************************************	*****	**************************************
**************************************	****** > to to	CHEMICAL chemical reaction rate gas solubility
*********************** THERMAL ARRHENIUS EQUATION temperature HENRY'S LAW temperature	***** > to to *****	CHEMICAL chemical reaction rate gas solubility
********************** THERMAL ARRHENIUS EQUATION temperature HENRY'S LAW temperature ***********************************	***** > to to *****	CHEMICAL chemical reaction rate gas solubility chemical CHEMICAL
************************ THERMAL ARRHENIUS EQUATION temperature HENRY'S LAW temperature ***********************************	***** > to to *****	CHEMICAL chemical reaction rate gas solubility chemical CHEMICAL
**************************************	***** > to to *****	CHEMICAL chemical reaction rate gas solubility ***********************************

$\begin{array}{c} & \underline{\text{APPENDIX}} \;\; \underline{\text{K}} \\ \\ \text{OPTICAL} \;\; \text{OUTPUT} \;\; \text{PRINCIPLES} \end{array}$

NUCLEAR	>	OPTICAL	
CERENKOV EFFECT electrons gamma ray radiation	to to	light emission light emission	
FISSION nuclear bombardment nuclear bombardment nuclear bombardment nuclear bombardment	to to to	radiation, electromagnetic heat optical power ionizing radiation	
GEIGER EFFECT nuclear radiation	to	light emission	
LUMINESCENCE optical power nuclear radiation electromagnetic wave	to to to	light emission light emission light emission	
RADIATION DARKENING ionizing radiation	to	absorptance	
में के	****	***********************************	
CHEMICAL	>	OPTICAL	
ABSORPTION chemical composition thickness	to to	optical power optical power	
BIOLUMINESCENCE biological mechanism	to	light emission	
COMBUSTION oxidation oxidation	to to	light emission heat	
CRYSTALLUMINESCENCE crystallization	to	light emission	
LAMBERT'S LAW thickness chemical concentration	to to	optical power optical power	
OPTICAL ROTATION chemical concentration chemical composition	to to	polarization polarization	
VARIABLE DENSITY chemical concentration	to	refractive index	
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OPTICAL	>	OPTICAL	
AMPLITUDE MODULATION absorptance polarization coupling coefficient transmissivity optical coupling	to to to	optical power optical power optical power optical power optical power optical power	
BREWSTER'S LAW polarizing angle	to	max polarized light	
CHRISTIANSEN EFFECT refractive index	to	optical power	
COLOR MIXING primary colors	to	any color	
LENS SYSTEM optical image	to	optical image	
LUMINESCENCE optical power nuclear radiation electromagnetic wave	to to to	light emission light emission light emission	
NTIR refractive index	to	optical power	
PHASE INTERFEROMETER phase difference refractive index	to to	optical power optical power	
PHOTOLUMINESCENCE visible light	to	light emission	
SNELL'S LAW reflectivity	to	optical power	
VARIABLE REFLECTIVITY refractive index	to	optical power	
*****************	****	******	
MAGNETIC	>	OPTICAL	
FARADAY ROTATION magnetic field	to	polarization	
KERR MAGNETO-OPTIC EFFECT flux density	to	polarization	
LIQUID CRYSTAL temperature magnetic field	to to	opaqueness opaqueness	
LUMINESCENCE optical power nuclear radiation electromagnetic wave	to to to	light emission light emission light emission	
<u>************************</u>	****	*****************	

THERMAL	>	OPTICAL	
BLACKBODY RADIATION temperature	to	radiant heat	
ENERGY BANDGAP SHIFT temperature	to	absorptance	
GLADSTONE & DALE'S LAW temperature stress	to to	refractive index refractive index	
INCANDESCENCE heat	to	light emission	
LIQUID CRYSTAL temperature magnetic field	to to	opaqueness opaqueness	
MIRAGE EFFECT heat	to	deceptive image	
STEFAN-BOLTZMANN LAW temperature	to	radiant heat	
THERMO-OPTIC temperature	to	refractive index	
WIEN'S DISPLACEMENT LAW temperature	to	max energy wavelength	
•			
• *************	*****		
•		*********	

**************************************	>	**************************************	
******************* MECHANICAL ABSORPTION chemical composition thickness COULOMB'S LAW	to to	********** OPTICAL optical power optical power	
***************** MECHANICAL ABSORPTION chemical composition thickness COULOMB'S LAW proximity DIFFRACTION	to to	********** OPTICAL optical power optical power optical coupling	
****************** MECHANICAL ABSORPTION chemical composition thickness COULOMB'S LAW proximity DIFFRACTION wire diameter	to to to	********** OPTICAL optical power optical power optical coupling optical power	
MECHANICAL	to to to to	********* OPTICAL optical power optical power optical coupling optical power frequency, optical	
**************** MECHANICAL ABSORPTION	to to to to to	********* OPTICAL optical power optical power optical coupling optical power frequency, optical refractive index coupling coefficient	
MECHANICAL	to to to to to	********* OPTICAL optical power optical power optical coupling optical power frequency, optical refractive index	
**************** MECHANICAL ABSORPTION	to to to to to	********* OPTICAL optical power optical power optical coupling optical power frequency, optical refractive index coupling coefficient	

LAMBERT'S COSINE LAW angle	to	illumination
LAMBERT'S LAW thickness chemical concentration	to to	optical power optical power
LASER EXTERNAL MIRROR position	to	optical power
NUMERICAL APERTURE displacement	to	coupling coefficient
OPTICAL INTERFERENCE path length difference	to	optical power
PHOTOELASTIC EFFECT stress strain	to to	polarization reflectivity
PIEZO-OPTICAL EFFECT stress stress	to to	dielectric constant refractive index
RADIATIVE LOSSES microbends	to	absorptance
SAGNAC PHASE SHIFT rotation	to	phase difference
SCHLIEREN GRATING displacement	to	transmissivity
SONOLUMINESCENCE acoustic energy ultrasonic	to to	light emission light emission
TRIBOLUMINESCENCE friction pressure	to to	light emission light emission
VARIABLE BIREFRINGENCE strain	to	polarization
VARIABLE OPACITY position	to	optical power
VARIABLE REFRACTIVE INDEX liquid level	to	reflectivity
والدوال والدوالة	راد داد داد داد داد	اما الما الما داد داد داد داد والرواي

ELECTRICAL	>	OPTICAL	
CERENKOV EFFECT electrons gamma ray radiation	to to	light emission light emission	
ELECTROLUMINESCENCE ac electric field	to	light emission	
ELECTRO-OPTICAL EFFECT emf emf	to to	dielectric constant refractive index	
KERR EFFECT electric field electric field	to to	polarization optical power	
LED ELECTRO-OPTIC current	to	optical power	
LUMINESCENCE optical power nuclear radiation electromagnetic wave	to to to	light emission light emission light emission	
STARK EFFECT electric field	to	spectral line separation	
********	k sie sie sie sie s	******	

APPENDIX L MAGNETIC OUTPUT PRINCIPLES

NUCLEAR	>	MAGNETIC	
FISSION nuclear bombardment nuclear bombardment nuclear bombardment nuclear bombardment ************************************	to to to to	radiation, electromagnetic heat optical power ionizing radiation	
CHEMICAL	>	MAGNETIC	
	rakakakaka	e die die die die die die die die die di	
OPTICAL	>	MAGNETIC	
PHOTOMAGNETIC EFFECT optical power	to	paramagnetism	
the tile tile tile tile tile tile tile til	estestestest	e she she she she she she she she she sh	
MAGNETIC	>	MAGNETIC	
BARKHAUSEN EFFECT magnetic field	to	flux density	
WIEGAND EFFECT magnetic field	to	flux change	
************************	richt ich ich	***************	
THERMAL	>	MAGNETIC	
CURIE-WEISS LAW temperature	to	permeability	
************************************	****	त्रीत के को की	

MECHANICAL	>	MAGNETIC		
BARNETT EFFECT rotation	to	magnetization		
DOPPLER (MAGNETIC) velocity	to	frequency, electromagnetic		
FLUX DENSITY position	to	magnetic field		
INDUCTIVE EDDY CURRENT proximity	to	magnetic field		
MAGNETOSTRICTION strain magnetic field	to to	magnetic field strain		
VILLARI EFFECT stress	to	magnetic induction		

ELECTRICAL	>	MAGNETIC		
FARADAY INDUCTION flux change current	to to	emf magnetic field		

$\begin{array}{c} \underline{\text{APPENDIX}} \ \underline{\text{M}} \\ \\ \text{THERMAL} \ \text{OUTPUT} \ \text{PRINCIPLES} \end{array}$

NUCLEAR	>	THERMAL	
nuclear bombardment nuclear bombardment nuclear bombardment	to to to	radiation, electromagnetic heat optical power ionizing radiation	
ं के को	ententententent	e sie sie sie sie sie sie sie sie sie si	
CHEMICAL	>	THERMAL	
COMBUSTION oxidation oxidation	to to	light emission heat	
ELECTROLYTIC DISSOCIATION chemical concentration	to	freezing point	
PHOTOABSORPTION chemical composition optical power radiant heat	to to to	temperature temperature temperature	
flow velocity	to to to to to	temperature temperature temperature temperature temperature temperature temperature	
*** *** *** *** *** *** *** *** *** **	e ste ste ste ste st		
OPTICAL	>	THERMAL	
PHOTOABSORPTION chemical composition optical power radiant heat	to to to	temperature temperature temperature	
******	entententent	*******************************	
MAGNETIC	>	THERMAL	
THERMOMAGNETIC magnetic field intensity	to	thermoresistance	
*******	erkerkerkerk	*******************	

THERMAL	>	THERMAL		
FOURIER'S LAW temperature	to	heat flux		
RIGHI-LEDUC EFFECT heat transfer rate	to	temperature difference		
THERMAL CONDUCTIVITY air velocity mass flow rate flow velocity heat transfer rate separated gases chemical composition	to to to to	temperature temperature temperature temperature temperature temperature temperature		
*******************	****	ske		
MECHANICAL	>	THERMAL		
CRAFT'S RULE pressure	to	boiling point		
HOT WIRE air velocity	to	temperature		
PIEZOCALORIC stress	to	heat		
THERMAL CONDUCTIVITY air velocity mass flow rate flow velocity heat transfer rate separated gases chemical composition	to to to to	temperature temperature temperature temperature temperature temperature temperature		
ंद के	****	में तह में के तह में की मे		
ELECTRICAL	>	ELECTRICAL		
BENEDICK EFFECT emf	to	temperature difference		
ETTINGSHAUSEN EFFECT current	to	temperature difference		
JOULE'S LAW current	to	temperature		
PELTIER EFFECT current	to	temperature cooling		
SPARK GAP (PASCHEN'S LAW) emf emf	to	heat ionization		
<u> </u>	rkrikrikrikrik	the		

APPENDIX N MECHANICAL OUTPUT PRINCIPLES

NUCLEAR>		MECHANICAL		

CHEMICAL	>	MECHANICAL		
ATMOLYSIS chemical composition	to	separated gases		
CAPILLARY COLUMN gas sample	to	separated gases		
CHEMISORPTION gas concentration NO concentration vapor concentration	to to to	capacitance resistance elastic properties		
JONES EFFECT salt concentration	to	surface tension		
OSMOSIS chemical composition	to	pressure		
PARAMAGNETISM oxygen concentration	to	magnetic attraction .		

OPTICAL	>	MECHANICAL		
RADIATION PRESSURE light	to	force		
*****	****	* * * * * * * * * * * * * * * * * * * *		
MAGNETIC	>	MECHANICAL		
EINSTEIN-DE HASS EFFECT sudden magnetization	to	angular momentum		
MAGNETIC ANISOTROPY magnetization direction	to	force		
MAGNETIC SOUND DISPERSION magnetic field	to	acoustic frequency		
MAGNETOSTRICTION strain magnetic field	to to	magnetic field strain		

```
THERMAL ----- MECHANICAL
THERMAL EXPANSION
           temperature
                                                                                              volume
                                                                                to
           temperature
                                                                                to
                                                                                              pressure
And the state of t
MECHANICAL ...-- MECHANICAL
ACOUSTIC INTERFERENCE
           frequency, acoustic
                                                                                to
                                                                                              acoustic energy
ACOUSTIC PROPAGATION
                                                                                to
                                                                                              saw velocity
           elastic properties
ARCHIMEDE'S PRINCIPLE
                                                                                               force
           density
                                                                                to
BAUSCHINGER EFFECT
           prestrain
                                                                                               elastic properties
CAVITATION
           angular velocity
                                                                                to
                                                                                               sound
DOPPLER (ACOUSTIC)
                                                                                to
                                                                                              frequency, acoustic
           velocity
ELASTIC DEFORMATION acceleration
                                                                                              deflection
                                                                                to
           acceleration
                                                                                to
                                                                                              strain
           acceleration
                                                                                to
                                                                                              stress
           acoustic wave
                                                                                              strain
                                                                                to
           displacement
                                                                                to
                                                                                              position
           displacement
                                                                                to
                                                                                               strain
                                                                                              displacement
           force
                                                                                to
           force
force
                                                                                               position
                                                                                to
                                                                                              strain
deflection
                                                                                to
           pressure
                                                                                ţο
           pressure
                                                                                to
                                                                                              displacement
           pressure
                                                                                to
                                                                                              microbends
           pressure
                                                                                to
                                                                                              position
           pressure
                                                                                to
                                                                                              proximity
strain
           pressure
                                                                                to
           pressure
                                                                                to
                                                                                               tension
           pressure, sound
pressure, sound
pressure, sound
                                                                                to
                                                                                              displacement
                                                                                              position
                                                                                to
                                                                                              strain
                                                                                to
           saw
                                                                                to
                                                                                              strain
           shock
                                                                                tο
                                                                                               strain
           stress
                                                                                to
                                                                                              tension
           strain
                                                                                to
                                                                                              acoustic wave
                                                                                to
                                                                                              displacement
           strain
           strain
                                                                                 to
                                                                                              position
           strain
                                                                                 to
                                                                                               pressure, sound
           strain
                                                                                 to
                                                                                               รลพ
           strain
                                                                                 to
                                                                                               tension
           stress
                                                                                 to
                                                                                               strain
                                                                                to
                                                                                              strain
           tension
                                                                                               strain
                                                                                to
           torque
           vibration
```

(<

to

strain

ELASTIC LIMIT hardness	to	deformation	
EOTVOS EFFECT direction of motion	to	force	
GRAVITY PENDULUM inclination	to	position	
HYDRODYNAMIC ELEMENT fluid flow	to	force	
LORENTZ CONTRACTION velocity	to	length	
MECHANICAL RESONANCE length	to	acoustic frequency	
POISSON'S RATIO longitudinal stress	to	lateral contraction	
QUARTZ RESONATOR strain	to	resonant frequency	
RESONANCE liquid level density acoustic wave	to to to	flexural frequency torsional frequency frequency, acoustic	
ROTOR velocity, angular	to	position	
VIBRATING WIRE tension	to	frequency, mechanical	
VORTEX SHEDDING air velocity	to	density	

<u>*************************************</u>				
	ELECTRICAL>		MECHANICAL	
	AMPERE'S LAW current	to	force	
	ELECTRIC WIND EFFECT corona discharge	to	air movement	
	ELECTROACOUSTIC emf	to	pressure, sound	
	ELECTROCAPILLARITY emf	to	surface tension	
	ELECTRO-OSMOSIS emf	to	polar fluid movement	
	ELECTROSTRICTIVE emf emf electric field	to to to	stress strain strain	
	FERROELECTRIC electric field	to	dipole alignment	
	INTERDIGITAL TRANSDUCER saw emf	to to	emf saw	
	JOHNSEN-RAHBEK EFFECT emf	to	friction (solid)	
	PINCH EFFECT current	to	conductor diameter	
	WINSLOW EFFECT emf	to	friction (liquid)	

APPENDIX O ELECTRICAL OUTPUT PRINCIPLES

**************************************		**************************************	
FISSION nuclear bombardment nuclear bombardment nuclear bombardment nuclear bombardment	to to to	radiation, electromagnetic heat optical power ionizing radiation	
JOSHI EFFECT ionizing radiation	to	current	
PHOTOCONDUCTIVE ionizing radiation optical power	to to	resistance resistance	
PHOTOEMISSIVE ionizing radiation optical power	to to	electrons charge carrier	
PHOTOVOLTAIC ionizing radiation optical power optical power	to to to	emf emf electric field	
PIN PHOTOCURRENT ionizing radiation optical power	to to	current	
	icalealealealea	en de la	

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:S

OPTICAL	>	ELECTRICAL		
APD optical power	to	current		
BECQUEREL EFFECT illumination difference	to	emf		
CCD optical image	to	emf		
HALLWOCK'S EFFECT ultraviolet light	to	charge loss		
HERTZ EFFECT ultraviolet light	to	electrical spark		
JOSEPHSON JUNCTION infrared radiation magnetic field noise temperature emf resonant frequency	to to to to	current current current current current		
PHOTOCONDUCTIVE ionizing radiation optical power	to to	resistance resistance		
PHOTOEMISSIVE ionizing radiation optical power	to to	electrons charge carrier		
PHOTOVOLTAIC ionizing radiation optical power optical power	to to to	emf emf electric field		
PIN PHOTOCURRENT ionizing radiation optical power	to to	current current		

MAGNETIC	>	ELECTRICAL		
CORBINO EFFECT magnetic field	to	current		
FARADAY INDUCTION flux change current	to to	emf magnetic field		
GALVANOMAGNETIC (HALL) static magnetic field static magnetic field dynamic magnetic field	to to to	dc emf ac emf ac emf		
GAUSS EFFECT magnetic field	to	resistance		
JOSEPHSON JUNCTION infrared radiation magnetic field noise temperature emf resonant frequency	to to to to	current current current current current		
MAGNETORESISTANCE magnetic field	to	impedance		
SENSING COIL inductance flux change	to to	emf emf		
VARIABLE PERMEABILITY magnetic field	to	resonant frequency		

THERMAL>		ELECTRICAL		
EDISON EFFECT temperature	to	vacuum current		
JOSEPHSON JUNCTION infrared radiation magnetic field noise temperature emf resonant frequency	to to to to	current current current current current		
MATTHEISSEN'S RULE temperature	to	resistivity		
NERNST EFFECT temperature gradient	to	ac emf		
PTAT temperature	to	emf		
PYROELECTRIC temperature change	to	emf		
TCD thermal conductivity	to	emf		
THERMOCONDUCTANCE temperature	to	conductivity		
THERMOELECTRIC (SEEBECK) temperature temperature	to to	emf current		
THERMORESISTANCE temperature	to	resistance		
THERMOVOLTAIC JUNCTION temperature	to	emf		
VARIABLE DIELECTRIC liquid level deflection chemical state temperature	to to to	capacitance capacitance gate resistance capacitance		
WORKMAN-REYNOLDS EFFECT freezing point	to	emf		

MECHANICAL	>	ELECTRICAL		
ACOUSTOELECTRIC pressure, sound	to	emf		
CONDUCTIVE ELASTOMER position shape force	to to to	resistance resistance resistance		
DOPPLER (ELECTRIC) velocity	to	frequency,	electromagnetic	
DORN EFFECT (ELECTROKINETIC) particle immersion	to	emf		
INTERDIGITAL TRANSDUCER saw emf	to to	emf saw		
ION MOVEMENT flow	to	current		
MECHANICAL SWITCH position	to	resistance		
OSCILLATOR resonant frequency current impedance	to to to	emf frequency, frequency,	electric electric	
PIEZOELECTRIC stress stress strain strain frequency, resonant flexural frequency torsional frequency	to to to to to	emf charge emf charge ac emf emf		
PIEZO-OPTICAL EFFECT stress stress	to to	dielectric refractive	constant index	
PIEZORESISTANCE strain	to	resistance		
PN PIEZOJUNCTION strain	to	current		
POTENTIOMETRIC dimension position	to to	resistance resistance		
PROXIMITY EFFECT conductor proximity	to	resistance		
RESISTANCE-PRESSURE EFFECT pressure	to	resistance		
THERMOELASTIC EFFECT stress	to	emf		

VARIABLE CONDUCTIVITY liquid level	to	resistance		
VARIABLE DIELECTRIC liquid level deflection chemical state temperature	to to to	capacitance capacitance gate resistance capacitance		
VARIABLE RELUCTANCE position displacement velocity position position, angular	to to to to	magnetic field inductance inductance inductance inductance inductance		
WERTHEIM EFFECT torque	to	emf		
de d				

ें के	****	the
ELECTRICAL	>	ELECTRICAL
BRIDGE CIRCUIT resistance resistance	to to	restoring current
CAPACITIVE PI-FET charge	to	emf
CFT gate resistance	to	current
CHARGE AMPLIFIER charge charge	to to	emf current
CHARGE MOBILITY charge carrier	to	resistance
DIFFERENTIAL TRANSFORMER inductance	to	emf
ECKO impedance	to	emf
ECOLD impedance	to	emf
ELECTRO-OPTICAL EFFECT emf emf	to to	dielectric constant refractive index
GATE CONTROLLED DIODE ionic concentration dielectric constant	to to	gate emf gate emf
IMPEDANCE electrical frequency	to	current
INDUCTION current	to	emf
ISFET charge chemical composition	to to	current current
JOSEPHSON JUNCTION infrared radiation magnetic field noise temperature emf resonant frequency	to to to to	current current current current current
MOS CAPACITOR capacitance	to	emf

OHM'S LAW emf resistance	to to	current current
OSCILLATOR resonant frequency current impedance	to to to	emf frequency, electric frequency, electric
PHASE SHIFT OSCILLATOR resistance	to	emf (fm)
PIN charge carrier	to	current
PLL frequency difference	to	emf
POWER LAW power current voltage resistance	to to to	current power power power
QUANTUM INTERFEROMETER current	to	emf
SENSING COIL inductance flux change	to to	emf emf
SIGNAL PROCESSING electrical measurand	to	electrical measurand
SPARK GAP (PASCHEN'S LAW) emf emf	to to	heat ionization
UNIJUNCTION OSCILLATOR current	to	frequency, electric
VARISTOR emf	to	resistance
WIEN EFFECT emf	to	conductivity
ZENER EFFECT voltage	to	current

proposed. It contains the same information as a transduction path diagram, but is in a more convenient form for the path generation process. The tree illustrates all of the possible paths through the transduction path diagram which lead from a given input measurand to an electrical output signal.

The number of levels in the tree is determined by the number of steps in the desired transduction path. For each additional step in the transduction path, the number of branches in the highest level increases by a factor of seven. For example, a one step tree would have 1 branch, a two step tree would have 7 branches, and a three step tree would have 49 branches in the highest level. To further illustrate this point, one, two, and three step trees are presented below. Also presented is a tree which covers the general case of a transduction path consisting of an arbitrary number of steps.

The shortest possible transduction path consists of only one step. By definition, the one step is required to be an electrical modifier. Furthermore, the tree necessary to generate a one step transduction path consists of only a single branch as illustrated in Figure P.l. The input measurand is an electrical quantity, as is the output measurand. The number embedded in the arrow indicates the number of known principles which permit the indicated transduction or modification to occur.

To utilize the tree, one would examine the 28 electrical modification elements listed in Table XII to determine which have the proper input measurand. Once this has been accomplished, the designer would have a listing of possible one step transduction paths which lead from the desired input measurand to an electrical output signal.

A two step transduction path may consist of a transduction step followed by an electrical modifier, or it

ELEC --28--> ELEC

Figure P.1 One Step Design Tree.

may consist of a modification step followed by an electrical modifier. In either case, the last step is an electrical modifier. It is this fact which leads to the observation that the two step design tree is simply the one step tree with one additional level, or set of branches. As such, the two step tree would have 7 branches in its highest level and appear as illustrated in Figure P.2.

The input measurand may be any one of the seven forms of energy while the output measurand would be an electrical signal. The output of the first step represents an intermediate measurand which is used as the input to the second step. In this case, the intermediate measurand is electrical in nature.

To utilize the tree, one would first identify the energy input measurand. Once this accomplished, Tables XI and XII would be examined to of the determine which transduction or modification principles listed therein have the proper input measurand. The principles so identified would be candidates for first step of the transduction path. Their output measurands would become intermediate measurands pending the second step of the transduction path. Next, electrical modification principles in Table XII would be examined to determine which of these have input measurands compatible with the intermediate measurand noted above. These principles would be candidates for the second step of the transduction path. The candidates for the two steps

would then be combined into complete transduction paths, with care taken to ensure the input and output measurands of consecutive steps mesh properly. The combinations of steps thus generated would represent a listing of all possible two step transduction paths which lead from the desired input measurand to an electrical output signal.

```
NUCL --06--> ELEC
CHEM --11--> ELEC
OPTI --10--> ELEC
MAGN --08--> ELEC ELEC --28--> ELEC
THER --13--> ELEC
MECH --20--> ELEC
ELEC --28--> ELEC
```

Figure P.2 Two Step Design Tree.

A three step transduction path may exist in four different configurations. The first and second steps may be either transduction or modification elements. This leads to the conclusion that only four combinations are possible, since the last step has to be an electrical modifier.

In a manner similar to that of the one and two step transduction path trees described above, the three step tree is likewise an extension of the two step design tree. Another level with seven times the original number of branches is added to the two step tree. This results in a three step tree which has 49 branches in its highest level and would appear as illustrated in Figure P.3.

Once again, the input measurand may be any one of the seven forms of energy. However, in the three step tree, there are two intermediate measurands instead of only one. The outputs of the first and second steps serve as inputs to the subsequent steps and therefore are intermediate

```
NUCL --01--> NUCL CHEM --00--> NUCL
OPTI --00--> NUCL MAGN --00--> NUCL NUCL --06--> ELEC THER --00--> NUCL
MECH -- 01--> NUCL
           --ŌĪ--> NŬČĪ
NUCL --00--> CHEM CHEM --02--> CHEM OPTI --02--> CHEM
MAGN --00-->
THER --02-->
                               CHEM CHEM --11--> ELEC
CHEM
CHEM
MECH --00-->
ELEC --01-->
NUCL --05--> OPTI
CHEM --07--> OPTI
OPTI --11--> OPTI
MAGN --04--> OPTI OPTI --10--> ELEC
THER --09--> OPTI
MECH --24--> OPTI
ELEC --07--> OPTI
NUCL --01--> MAGN
CHEM --00--> MAGN
OPTI --01--> MAGN
MAGN --02--> MAGN MAGN --08--> ELEC ELEC --28--> ELEC
THER --01--> MAGN
MECH --06--> MAGN
ELEC --01--> MAGN
NUCL --01-->
CHEM --04-->
OPTI --01-->
                               THER
THER
THER
MAGN --01--> THER THER --13--> ELEC
THER --03--> THER
MECH --04--> THER
ELEC --05--> THER
NUCL --00--> MECH
CHEM --06--> MECH
OPTI --01--> MECH
MAGN --04--> MECH MECH --20--> ELEC
THER --01--> MECH
MECH --19--> MECH
ELEC --11--> MECH
NUCL --06--> ELEC
CHEM --11--> ELEC
OPTI --10--> ELEC
MAGN --08--> ELEC ELEC --28--> ELEC THER --13--> ELEC MECH --20--> ELEC ELEC --28--> ELEC
```

Figure P.3 Three Step Design Tree.

measurands. The first intermediate measurand may be any one of the seven forms of energy. However, the second intermediate measurand must be electrical in nature. This is due to the fact that the last step is required to be an electrical modifier.

To utilize the tree, one would first identify the energy form of the input measurand. Once this has been accomplished, Tables IX through XVII would be examined to determine which of the transduction or modification principles listed therein have the proper input measurand. The principles so identified would be candidates for the first step of the transduction path. Their output measurands would become intermediate measurands, pending the second step of the transduction path.

At this point, Tables XI and XII would be examined to determine which of the transduction or modification principles listed therein have an input measurand which corresponds to the first intermediate measurand identified above. The principles so identified would be candidates for the second step of the transduction path. Their output measurands would become intermediate measurands, pending the third step of the transduction path.

Finally, the 28 electrical modification principles in Table XII would be examined to determine which of these have input measurands compatible with the second intermediate measurand noted above. These principles would be candidates for the third step of the transduction path.

The candidates for the three steps would then be combined into complete transduction paths, with care taken to ensure the input and output measurands of consecutive steps mesh properly. The sequences of steps resulting from this combination process would represent all possible three step transduction paths which lead from the desired input measurand to an electrical output signal.

In Chapter V, examples of existing transducers were presented which had transduction paths up to seven steps in length. However, thus far in this appendix, design trees capable of handling transduction paths of only three steps or less have been presented. What is necessary is a general case design tree capable of handling any length of transduction path.

The key to the development of such a tree is recognition of the fact that the branches of the tree repeat in all but the lowest two levels. Examination of the three step design tree illustrated in Figure P.3 reveals that the third, or highest level, consists of entries from Tables IX through XVII. Table XVII, with all nuclear output measurands, appears at the top left of the three step tree while Tables XI and XII, with all electrical output measurands, appear at the bottom left.

Extrapolating to the case of a four step tree, it becomes apparent that the fourth level would simply be the third level repeated seven times. An entire block of tables with Table XVII at the top and Tables XI and XII at the bottom is appended to the left of each table in each level until the desired number of levels is achieved. The completed structure would appear as illustrated in Figure P.4.

As stated earlier, the second level will always consist of principles which have an electrical output measurand. It is for this reason that the second level may be represented by Tables XI and XII. Likewise, the first level, or last step in a transduction path, will always be an electrical modifier. It is for this reason that the last step is represented by the words "Signal Processing".

procedure is followed as was utilized in the three step design tree. The only factor that will vary is the number

```
-TABLE XVII----
--TABLE XVII-----

--TABLE XVI-----

--TABLES XIV,XV-

--TABLE XIII----

--TABLE X------

--TABLE IX-----

--TABLE IX-----

--TABLES XI,XII--
--TABLE XVII-----
--TABLE XVI-----
--TABLES XIV,XV--
--TABLE XIII-----
--TABLE X-------
--TABLE IX-------
--TABLE XXI,XII-
                                                           -TABLES XIV, XV-
--TABLE XVII----

--TABLE XVI----

--TABLES XIV, XV-

--TABLE XIII----

--TABLE X------

--TABLE IX-----

--TABLES XI, XII--
                                                                                                                                                                                       ROCESSING
--TABLE XVII----

--TABLE XVI----

--TABLES XIV,XV-

--TABLE XIII----

--TABLE X------

--TABLE IX------

--TABLES XI,XII--
                                                           -TABLE X-----
--TABLE XVII-----

--TABLE XVI------

--TABLES XIV,XV-

--TABLE XIII-----

--TABLE X-------

--TABLE IX-------

--TABLES XI,XII--
                                                           -TABLE IX----
--TABLE XVII-----
--TABLE XVI------
--TABLES XIV,XV-
--TABLE XIII----
--TABLE X-------
--TABLE IX------
--TABLE XXI,XII--
                                                           -TABLES XI,XII--
```

Figure P.4 General Case Design Tree.

of intermediate measurands. For example, a four step transduction path would have three intermediate measurands, while a ten step transduction path would have nine intermediate measurands.

APPENDIX Q SECONDARY MEASURANDS

In order to fully evaluate the relative advantages and disadvantages of various proposed transduction paths, it is necessary to consider secondary measurands. Secondary measurands may be defined as those physical quantities which are transduced or modified simultaneously with the desired input measurand. For example, the piezoelectric effect is often utilized in transducers to measure a mechanical strain. Unfortunately, the piezoelectric effect is also susceptible to thermal and electrical influences which will affect the manner in which strain is measured.

Thus far, the main transduction path has been illustrated by a series of asterisks (****) on the transduction path diagram which connect consecutive numbers. However, in order to show the effect of secondary measurands on the transduction path diagram, a new convention needs to be set. Henceforth, paths followed by secondary measurands through the transduction path diagram will be indicated by a series of dots (....). In order to illustrate the necessary techniques, an example of a sensor which is susceptible to secondary measurands is presented below.

An example of a sensor which may be influenced by secondary measurands is the piezoelectric pressure sensor. The transduction path consists of a modification followed by a transduction and a modification. The first step is elastic deformation, which converts pressure to a mechanical strain. The second step is the piezoelectric effect which converts a mechanical strain to an electrical charge. The last step is an electrical modifier which is chosen to convert electrical charge to a suitable electrical output signal.

The principle of elastic deformation is susceptible to temperature as a secondary measurand. As the temperature of an elastic device is raised or lowered, the elastic properties change. This decalibrates the device and causes larger or smaller strain to be generated than would otherwise be expected. Therefore, temperature is undesirable, or secondary, measurand which changes the desired output measurand. This may be illustrated on the transduction path diagram by a series of dots which parallel to the main transduction step. In this case, new line would begin in the thermal input measurand block on the left side of the diagram and terminate in the mechanical output column as seen in Figure Q.1.

The piezoelectric effect is susceptible to both thermal and electrical influences as secondary measurands. As the temperature of a piezoelectric film is raised or lowered, the electrical properties change. Since the piezoelectric effect is reversible, the application of an electric field will tend to increase or decrease the strain actually developed as a result of pressure. Furthermore, how well a piezoelectric film is isolated from its surroundings will affect the manner in which charge is lost through bleed-off paths. This will degrade the DC response of a piezoelectric film and cause decalibration over a period of time as charge is lost. These undesirable effects are illustrated in Figure Q.1.

In summary, the mechanical strain generated by the first step of the transduction path is affected by changes in operating temperature. The amount of charge generated by the second step is affected by changes in temperature, electric fields, and the presence of electrical bleed-off paths. With adequate knowledge of the principles involved it should be possible to determine if compensation for secondary effects is required.

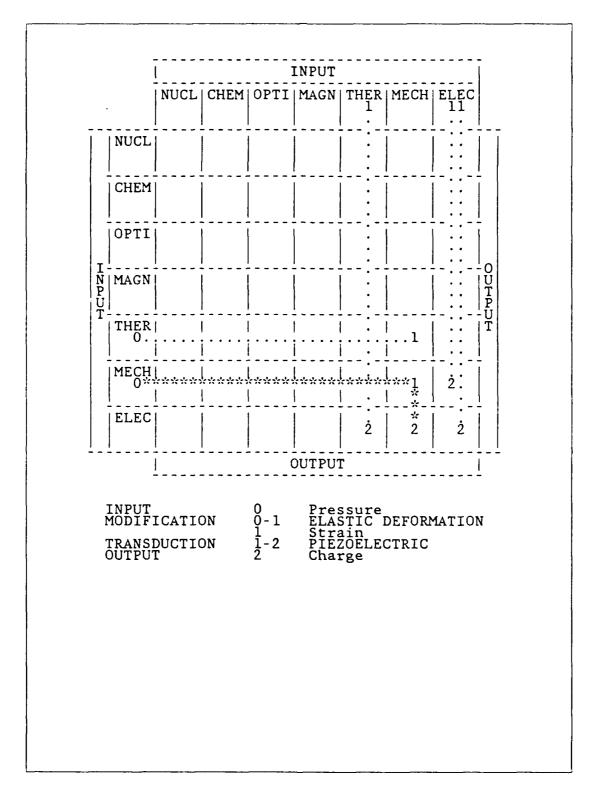


Figure Q.1 Secondary Measurand Diagram.

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